DS100KR800 8-Channel Repeater for Data-Rates Up to 10.3 Gbps

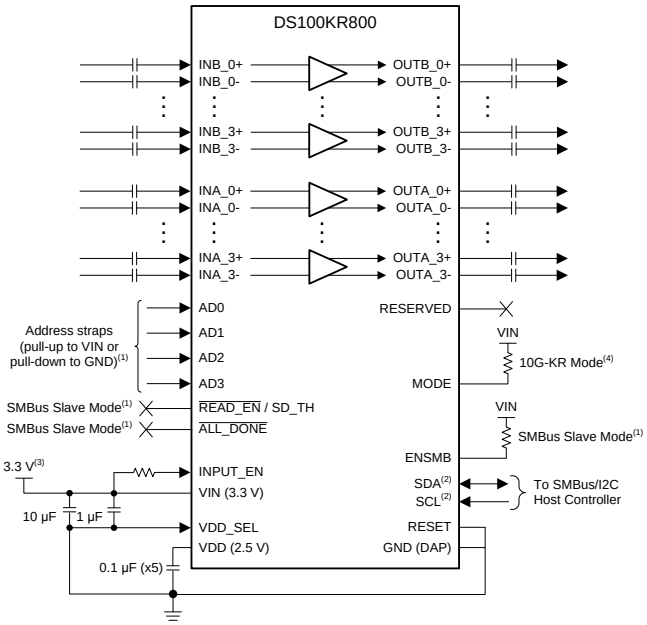
1 Features

- Comprehensive Product Family:
  - DS125BR820: 8-Channel Repeater
  - DS125BR401A: 4x Lane Repeater
  - DS125BR111: 1x Lane Repeater
- Transparent Management of 10G-KR (802.3ap) Link Training Protocol
- 65 mW/Channel (Typical) Power Consumption
- Advanced Signal Conditioning Features
  - Receive Equalization up to 36 dB at 5 GHz
  - Transmit De-emphasis up to –12 dB
  - Transmit Voltage Control: 700 mV to 1300 mV
- Programmable Through Pin Selection, EEPROM or SMBus Interface
- Selectable 2.5-V or 3.3-V Supply Voltage
- –40°C to +85°C Operating Temperature Range
- Flow-thru Pinout in Leadless WQFN Package

2 Applications

- Front-Port 40G-CR4/SR4/LR4 Link Extensions
- Backplane 40G-KR4 Link Extensions

Simplified Functional Block Diagram



(1) Schematic shows connection for SMBus Slave Mode (ENSMB=1 kW to VIN)
For SMBus Master Mode or Pin Mode configuration, the connections are different.
(2) SMBus signals need to be pulled up elsewhere in the system.
(3) Schematic requires different connections for 2.5 V mode.
(4) Schematic requires pull-down resistor for 10G Mode.

3 Description

The DS100KR800 device is a high performance repeater designed to support 8-channel (unidirectional), 10G-KR, and other high-speed interface serial protocols up to 10.3 Gbps. The continuous time linear equalizer (CTLE) of the receiver provides a boost of up to 36 dB at 5 GHz (10.3125 Gbps) in each of its eight channels. This equalizer is capable of opening an input eye that is completely closed due to inter symbol interference (ISI) induced by interconnect medium such as long backplanes or cables. The transmitter provides a de-emphasis boost of up to –12 dB and output voltage amplitude control from 700 mV to 1300 mV.

When operating in 10G-KR mode, the DS100KR800 transparently allows the host controller and the end point to optimize the full link and negotiate transmit equalizer coefficients as defined in the 802.3ap standard. This seamless management of the link training protocol ensures system level interoperability with minimum latency.

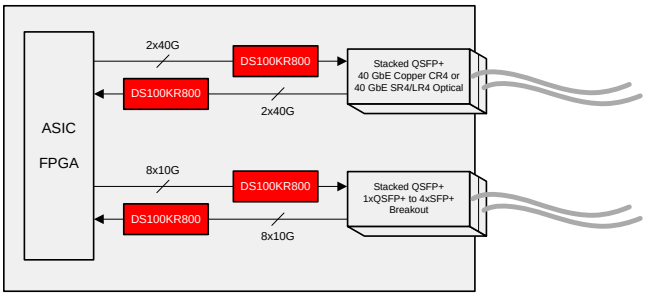
The programmable settings can be applied through pin settings, SMBus (I^2C) protocol or an external EEPROM. When operating in the EEPROM mode, the configuration information is automatically loaded on power-up. This eliminates the need for an external microprocessor or software driver.

Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
DS100KR800	WQFN (54)	10.00 mm × 5.50 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application Block Diagram



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (April 2013) to Revision E — **Page**

- Added *Pin Configuration and Functions* section, *ESD Ratings* table, *Feature Description* section, *Device Functional Modes*, *Application and Implementation* section, *Power Supply Recommendations* section, *Layout* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section ... 1
- Changed Signal detect pattern at 8 Gbps ... 7

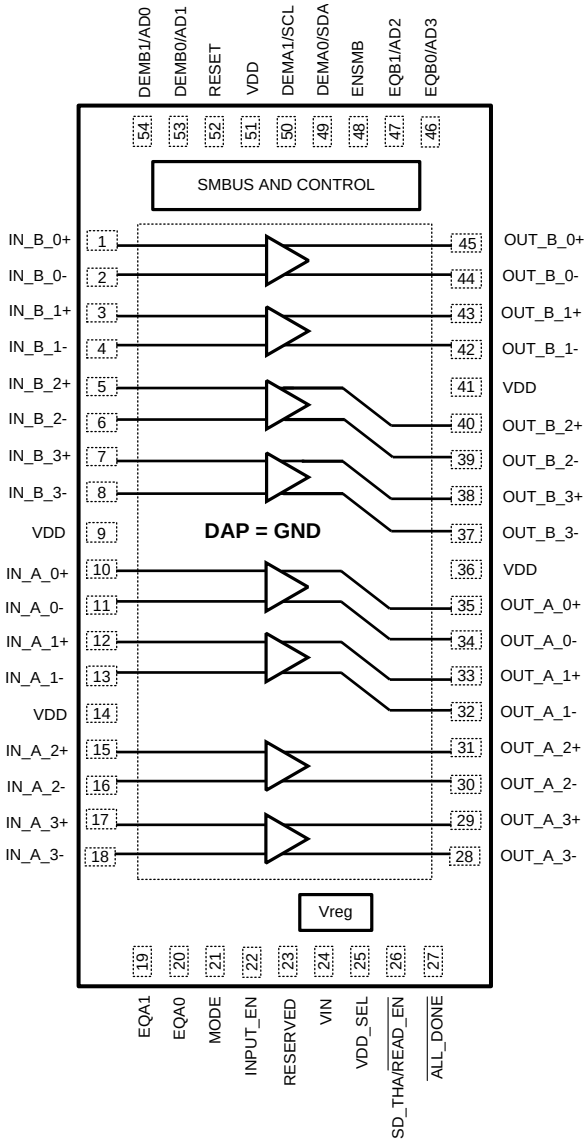
Changes from Revision C (April 2013) to Revision D — **Page**

- Changed layout of National Data Sheet to TI format ... 1

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5 Pin Configuration and Functions

NJY Package
54-Pin WQFN
Top View



Pin Functions: Common Connections[1][2][3][4]

PIN		TYPE	DESCRIPTION
NAME	NO.		
DIFFERENTIAL HIGH SPEED INPUTS AND OUTPUTS			
IN_A_0+, IN_A_0-, IN_A_1+, IN_A_1-, IN_A_2+, IN_A_2-, IN_A_3+, IN_A_3-	10, 11, 12, 13, 15, 16, 17, 18	I	Inverting and noninverting differential inputs to bank A equalizer. A gated on-chip 50-Ω termination resistor connects INA_n+ to VDD and INA_n- to VDD when enabled. AC coupling required on high-speed I/O.
IN_B_0+, IN_B_0-, IN_B_1+, IN_B_1-, IN_B_2+, IN_B_2-, IN_B_3+, IN_B_3-,	1, 2, 3, 4, 5, 6, 7, 8	I	Inverting and noninverting differential inputs to bank B equalizer. A gated on-chip 50-Ω termination resistor connects INB_n+ to VDD and INB_n- to VDD when enabled. AC coupling required on high-speed I/O.
OUT_A_0+, OUT_A_0-, OUT_A_1+, OUT_A_1-, OUT_A_2+, OUT_A_2-, OUT_A_3+, OUT_A_3-	35, 34, 33, 32, 31, 30, 29, 28	O	Inverting and noninverting 50-Ω driver bank A outputs with de-emphasis. Compatible with AC-coupled CML inputs. AC coupling required on high-speed I/O.
OUT_B_0+, OUT_B_0-, OUT_B_1+, OUT_B_1-, OUT_B_2+, OUT_B_2-, OUT_B_3+, OUT_B_3-,	45, 44, 43, 42, 40, 39, 38, 37	O	Inverting and noninverting 50-Ω driver bank B outputs with de-emphasis. Compatible with AC-coupled CML inputs. AC coupling required on high-speed I/O.
CONTROL PINS — SHARED (LVCMOS)			
ENSMB	48	I, LVCMOS	System Management Bus (SMBus) enable pin Tie 1 kΩ to VDD = Register Access SMBus Slave mode FLOAT = Read External EEPROM (Master SMBUS Mode) Tie 1 kΩ to GND = Pin Mode
CONTROL PINS — BOTH PIN AND SMBus MODES (LVCMOS)			
RESET	52	I, LVCMOS	LOW = Device is enabled (Normal Operation) HIGH = Low Power Mode
VDD_SEL	25	I, FLOAT	Controls the internal regulator Float = 2.5-V mode Tie GND = 3.3-V mode
POWER			
GND	DAP	Power	Ground pad (DAP - die attach pad).
VDD	9, 14, 36, 41, 51	Power	Power supply pins CML/analog 2.5-V mode, connect to 2.5 V 3.3-V mode, connect 0.1-µF cap to each VDD pin
VIN	24	Power	In 3.3-V mode, feed 3.3 V to VIN In 2.5-V mode, leave floating.

(1) LVCMOS inputs without the *Float* conditions must be driven to a logic low or high at all times or operation is not ensured.
(2) Input edge rate for LVCMOS/FLOAT inputs must be faster than 50 ns from 10–90%.
(3) For 3.3-V mode operation, VIN pin = 3.3 V and the VDD for the 4-level input is 3.3 V.
(4) For 2.5-V mode operation, VDD pin = 2.5 V and the VDD for the 4-level input is 2.5 V.

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Pin Functions: SMBus/EEPROM Control

PIN		TYPE	DESCRIPTION
NAME	NO.		
ENSMB = 1 (SMBUS MODE)			
AD0-AD3	54, 53, 47, 46	I, LVCMOS	ENSMB master or slave mode User set SMBus Slave Address Inputs in SMBus mode.
$\overline{\text{READ_EN}}$	26	I, 4-LEVEL, LVCMOS	When using an external EEPROM, a transition from high to low starts the load from the external EEPROM
SCL	50	I, LVCMOS, O, OPEN-Drain	ENSMB master or slave mode SMBUS clock input pin is enabled. Clock output when loading EEPROM configuration (master mode).
SDA	49	I, LVCMOS, O, OPEN-Drain	ENSMB master or slave mode The SMBus bidirectional SDA pin is enabled. Data input or open-drain output.
ENSMB = 0 (PIN MODE)			
MODE	21	I, 4-LEVEL, LVCMOS	Tie 1 kΩ to VDD = 10G-KR mode operation Tie 1 kΩ to GND = 10G mode operation
SD_TH	26	I, 4-LEVEL, LVCMOS	Controls the internal signal detect threshold See Table 4
CONTROL PINS — BOTH PIN AND SMBus MODES (LVCMOS)			
INPUT_EN	22	I, 4-LEVEL, LVCMOS	Tie 1 kΩ to VDD = normal operation
OUTPUTS			
$\overline{\text{ALL_DONE}}$	27	O, LVCMOS	Valid register load status output HIGH = external EEPROM load failed LOW = external EEPROM load passed

Pin Functions: Pin Control

PIN		TYPE	DESCRIPTION
NAME	NO.		
ENSMB = 0 (PIN MODE)			
DEMA0, DEMA1, DEMB0, DEMB1	49, 50, 53, 54	I, 4-LEVEL, LVCMOS	DEMA[1:0] and DEMB[1:0] control the level of de-emphasis of the output driver when in Gen1/2 mode. The pins are only active when ENSMB is deasserted (low). The 8 channels are organized into two banks. Bank A is controlled with the DEMA [1:0] pins and bank B is controlled with the DEMB[1:0] pins. When ENSMB is high the SMBus registers provide independent control of each channel. The DEMA[1:0] pins are converted to SMBUS SCL/SDA and DEMB[1:0] pins are converted to AD0, AD1 inputs. See Table 3
EQA0, EQA1, EQB0, EQB1	20, 19, 46, 47	I, 4-LEVEL, LVCMOS	EQA[1:0] and EQB[1:0] control the level of equalization on the input pins. The pins are active only when ENSMB is deasserted (low). The 8 channels are organized into two banks. Bank A is controlled with the EQA[1:0] pins and bank B is controlled with the EQB[1:0] pins. When ENSMB is high the SMBus registers provide independent control of each channel. The EQB[1:0] pins are converted to SMBUS AD2/ AD3 inputs. See Table 2
MODE	21	I, 4-LEVEL, LVCMOS	Tie 1 kΩ to VDD = 10G-KR mode operation Tie 1 kΩ to GND = 10G mode operation
SD_TH	26	I, 4-LEVEL, LVCMOS	Controls the internal signal detect threshold See Table 4
CONTROL PINS — BOTH PIN AND SMBus MODES (LVCMOS)			
INPUT_EN	22	I, 4-LEVEL, LVCMOS	Tie 1 kΩ to VDD = normal operation
RESERVED	23	I, FLOAT	Float = normal operation

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6 Specifications

6.1 Absolute Maximum Ratings

See (1)

		MIN	MAX	UNIT
Supply voltage (VDD = 2.5-V mode)		–0.5	2.75	V
Supply voltage (VIN = 3.3-V mode)		–0.5	4	V
LVCMOS input or output voltage		–0.5	4	V
CML input voltage		–0.5	(VDD + 0.5)	V
CML input current		–30	30	ma
Junction temperature			125	°C
Lead temperature	Soldering (4 sec.)(2)		260	°C
Derate NJY0054A package			52.6	mW/°C
Storage temperature, T_{stg}		–40	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) For soldering specifications: see product folder at SNOA549.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	±3000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101, all pins(2)	±1000	
		Machine model, STD - JESD22-A115-A	±200	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
Supply voltage	2.5-V mode	2.375	2.5	2.625	V
	3.3-V mode	3.0	3.3	3.6	V
Ambient temperature		–40	25	85	°C
SMBus (SDA, SCL)				3.6	V
Supply noise up to 50 MHz(1)				100	mVp-p

(1) Allowed supply noise (mVp-p sine wave) under typical conditions.

6.4 Thermal Information

THERMAL METRIC(1)		DS100KR800 NJY (WQFN) 54 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance, No Airflow, 4-layer JEDEC	26.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	10.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	4.4	°C/W
ψ_{JT}	Junction-to-top characterization parameter	0.2	°C/W
ψ_{JB}	Junction-to-board characterization parameter	4.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	1.5	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, SPRA953.

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6.5 Electrical Characteristics

See (1)(2)

PARAMETER		TEST CONDITIONS		MIN	TYP(3)	MAX	UNIT
POWER							
PD	Power dissipation	EQ enabled, VOD = 1 Vp-p, INPUT_EN = 1, RESET = 0	VDD = 2.5-V supply		500	700	mW
			VIN = 3.3-V supply		660	900	mW
LVCMOS / LVTTL DC SPECIFICATIONS							
V_{ih}	High level Input voltage	3.3-V mode operation (VIN = 3.3 V)		2		3.6	V
V_{il}	Low level Input voltage	3.3-V mode operation (VIN = 3.3 V)		0		0.8	V
V_{oh}	High level output voltage (ALL_DONE pin)	I_{oh} = –4 mA		2			V
V_{ol}	Low level output voltage (ALL_DONE pin)	I_{ol} = 4 mA				0.4	V
I_{ih}	Input high current (RESET pin)	VIN = 3.6 V, LVCMOS = 3.6 V		–15		15	µA
	Input high current with internal resistors (4–level input pin)	VIN = 3.6 V, LVCMOS = 3.6 V		20		150	µA
I_{il}	Input low current (RESET pin)	VIN = 3.6 V, LVCMOS = 0 V		–15		15	µA
	Input low current with internal resistors (4–level input pin)	VIN = 3.6 V, LVCMOS = 0 V		–160		–40	µA
CML RECEIVER INPUTS (IN_n+, IN_n-)							
$RL_{rx\text{-}diff}$	RX package pins plus Si differential return loss	0.05 GHz - 7.5 GHz			–15		dB
		7.5 GHz - 15 GHz			–5		dB
RLrx-cm	Common-mode RX return loss	0.05 GHz - 5 GHz			–10		dB
Zrx-dc	RX DC common-mode impedance	Tested at VDD = 0		40	50	60	Ω
Zrx-diff-dc	RX DC differential mode impedance	Tested at VDD = 0		80	100	120	Ω
Vrx-diff-dc	Differential RX peak-to-peak voltage	Tested at pins		0.6		1.2	V
Vrx-signal-det-diff-pp	Signal detect assert level for active data signal	SD_TH = F (float), 0101 pattern at 8 Gbps			180		mVp-p
Vrx-idle-det-diff-pp	Signal detect deassert level for electrical idle	SD_TH = F (float), 0101 pattern at 8 Gbps			110		mVp-p
HIGH SPEED OUTPUTS							
$V_{tx\text{-}diff\text{-}pp}$	Output voltage differential swing	Differential measurement with Out_n+ and OUT_n-, terminated by 50Ω to GND, AC-Coupled, VID = 1 Vp-p, DEM0 = 1, DEM1 = 0		0.8	1	1.2	Vp-p
$V_{tx\text{-}de\text{-}ratio_3.5}$	TXde-emphasis ratio	VOD = 1 Vp-p, DEM0 = 0, DEM1 = R			−3.5		dB
$V_{tx\text{-}de\text{-}ratio_6}$	TX de-emphasis ratio	VOD = 1 Vp-p, DEM0 = R, DEM1= R			–6		dB
$t_{TX\text{-}DJ}$	Deterministic jitter	VID = 800 mV, PRBS15 pattern, 8.0 0.05 Gbps, VOD = 1 V, UIpp EQ = 0x00, DE = 0 dB (no input or output trace loss)			0.05		UIpp

(1) Ensured by device characterization.
(2) The *Electrical Characteristics* tables list ensured specifications under the listed *Recommended Operating Conditions* except as otherwise modified or specified by the *Electrical Characteristics* conditions and/or notes. Typical specifications are estimations only and are not ensured.
(3) Typical values represent most likely parametric norms at VDD = 2.5V, TA = 25°C., and at the *Recommended Operation Conditions* at the time of product characterization and are not ensured.

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Electrical Characteristics (continued)

See (1)(2)

PARAMETER		TEST CONDITIONS	MIN	TYP (3)	MAX	UNIT
t_{TX-RJ}	Random jitter	VID = 800 mV, 0101 pattern, 8.0 Gbps, 0.3 VOD = 1 V, ps RMS EQ = 0x00, DE = 0 dB, (no input or output trace loss)		0.3		ps RMS
$T_{TX-RISE-FALL}$	Transmitter rise/fall time	20% to 80% of differential output voltage	35	45		ps
$T_{RF-MISMATCH}$	Transmitter rise/fall mismatch	20% to 80% of differential output voltage		0.01	0.1	UI
$RL_{TX-DIFF}$	Differential return loss	0.05 GHz - 7.5 GHz		–15		dB
		7.5 GHz - 15 GHz		–5		dB
RL_{TX-CM}	Common-mode return loss	0.05 GHz - 5 GHz		–10		dB
$Z_{TX-DIFF-DC}$	DC differential TX impedance			100		Ω
$V_{TX-CM-AC-PP}$	TX AC common-mode voltage	VOD = 1 Vp-p, DEM0 = 1, DEM1 = 0			100	mVp p
$I_{TX-SHORT}$	Transmitter short circuit current-limit	Total current the transmitter can supply when shorted to VDD or GND		20		mA
T_{PDEQ}	Differential propagation delay	EQ = 00, (4)		200		ps
T_{LSK}	Lane-to-lane skew	T = 25°C, VDD = 2.5 V		25		ps
T_{PPSK}	Part-to-part propagation delay skew	T = 25°C, VDD = 2.5 V		40		ps
EQUALIZATION						
DJE1	Residual deterministic jitter at 10.3 Gbps	35-in 4 mil FR4, VID = 0.8 Vp-p, PRBS15, EQ = 1F'h, DEM = 0 dB		0.3		UI
DJE2	Residual deterministic jitter at 10.3 Gbps	10 meters 30 awg cable, VID = 0.8 Vp-p, PRBS15, EQ = 2F'h, DEM = 0 dB		0.3		UI
DE-EMPHASIS						
DJD1	Residual deterministic jitter at 10.3 Gbps	20-in 4 mil FR4, VID = 0.8 Vp-p, PRBS15, EQ = 00, VOD = 1 Vp-p, DEM = −9 dB		0.1		UI

(4) Propagation Delay measurements will change slightly based on the level of EQ selected. EQ = 00 will result in the shortest propagation delays.

6.6 Electrical Characteristics – Serial Management Bus Interface

Over recommended operating supply and temperature ranges unless other specified.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SERIAL BUS INTERFACE DC SPECIFICATIONS						
V_{IL}	Data, clock input low voltage				0.8	V
V_{IH}	Data, clock input high voltage		2.1		3.6	V
I_{PULLUP}	Current through pullup resistor or current source	High power specification	4			mA
V_{DD}	Nominal bus voltage		2.375		3.6	V
$I_{LEAK-Bus}$	Input leakage per bus segment	See (1)	–200		200	µA
$I_{LEAK-Pin}$	Input leakage per device pin			–15		µA
C_I	Capacitance for SDA and SCL	See (1) (2)			10	pF

(1) Recommended value.
(2) Recommended maximum capacitance load per bus segment is 400pF.

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Electrical Characteristics – Serial Management Bus Interface (continued)

Over recommended operating supply and temperature ranges unless other specified.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
R_{TERM}	External termination resistance pull to V_{DD} = 2.5 V ± 5% OR 3.3 V ± 10%	Pullup V_{DD} = 3.3 V, See (1) (2) (3)		2000		Ω
		Pullup V_{DD} = 2.5 V, See (1) (2) (3)		1000		Ω

(3) Maximum termination voltage should be identical to the device supply voltage.

6.7 Timing Requirements – Serial Bus Interface Timing Specifications

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
FSMB	Bus operating frequency	ENSMB = VDD (slave mode)			400	kHz
		ENSMB = FLOAT (master mode)	280	400	520	kHz
T_{BUF}	Bus free time between stop and start condition		1.3			µs
$T_{HD:STA}$	Hold time after (repeated) start condition. After this period, the first clock is generated.	At I_{PULLUP}, maximum	0.6			µs
$T_{SU:STA}$	Repeated start condition set-up time		0.6			µs
$T_{SU:STO}$	Stop condition set-up time		0.6			µs
$T_{HD:DAT}$	Data hold time		0			ns
$T_{SU:DAT}$	Data set-up time		100			ns
T_{LOW}	Clock low period		1.3			µs
T_{HIGH}	Clock high period	See (1)	0.6		50	µs
t_F	Clock/Data fall time	See (1)			300	ns
t_R	Clock/Data rise time	See (1)			300	ns
t_{POR}	Time in which a device must be operational after power-on reset	See (1) (2)			500	ms

(1) Compatible with SMBus 2.0 physical layer specification. See System Management Bus (SMBus) Specification Version 2.0, section 3.1.1 SMBus common AC specifications for details.
(2) Ensured by Design. Parameter not tested in production.

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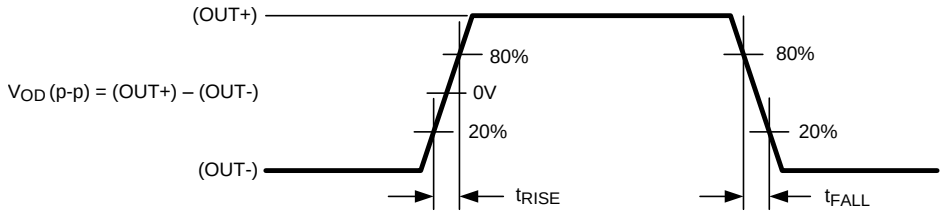


Figure 1. CML Output and Rise and Fall Transition Time

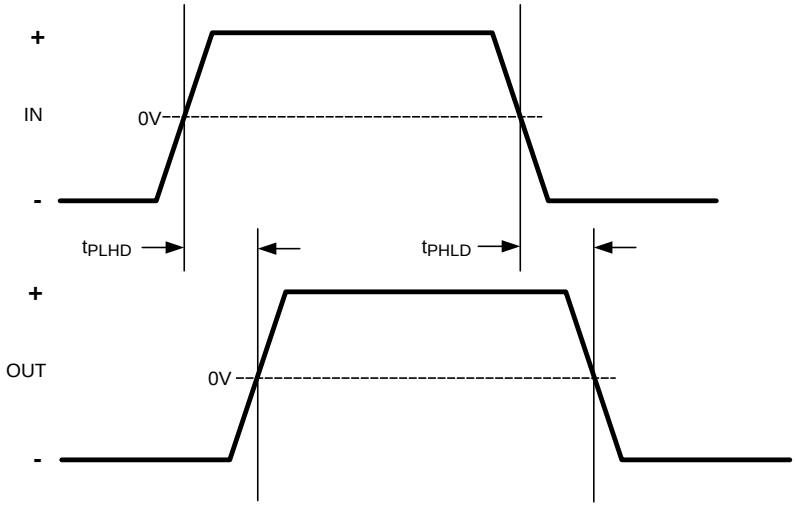


Figure 2. Propagation Delay Timing Diagram

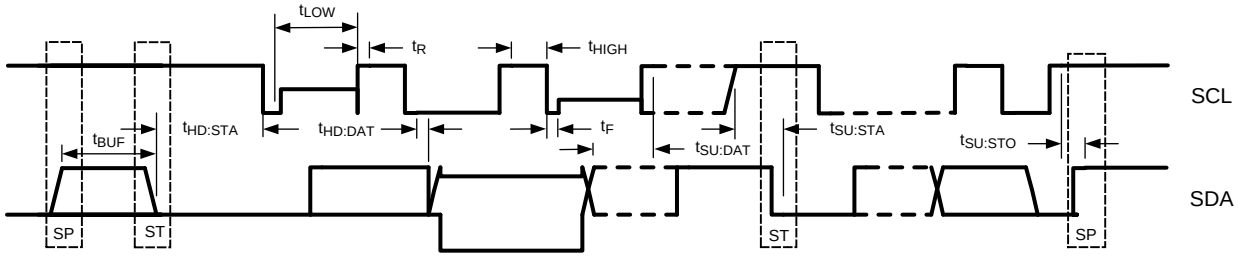


Figure 3. SMBus Timing Parameters

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6.8 Typical Characteristics

6.8.1 Electrical Performance

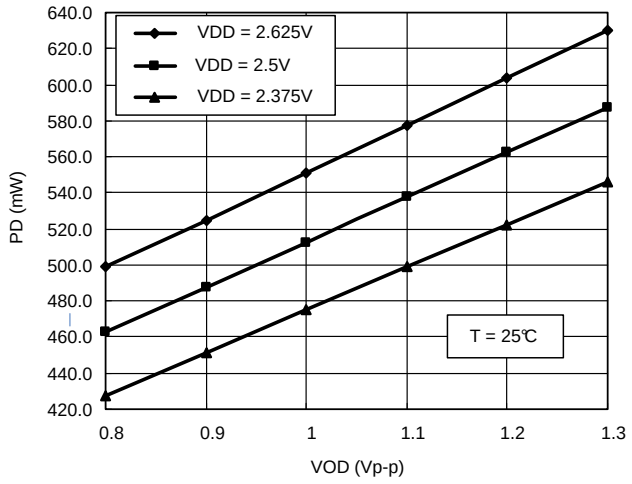


Figure 4. Power Dissipation (PD) vs Output Differential Voltage (VOD)

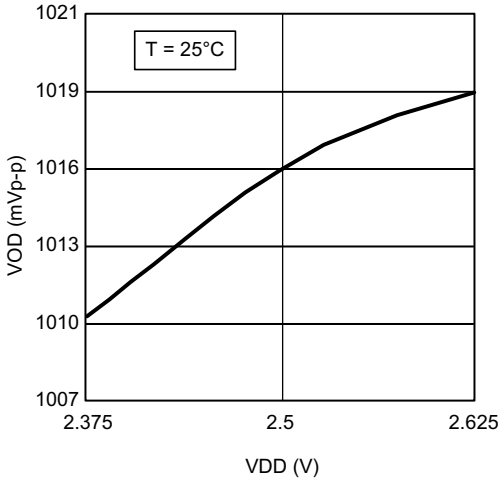


Figure 5. Output Differential Voltage (VOD = 1 Vp-p) vs Supply Voltage (VDD)

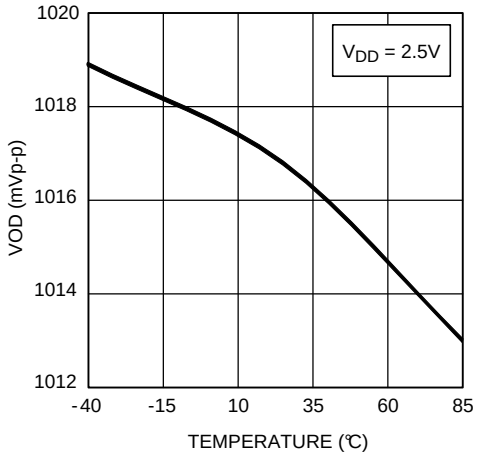


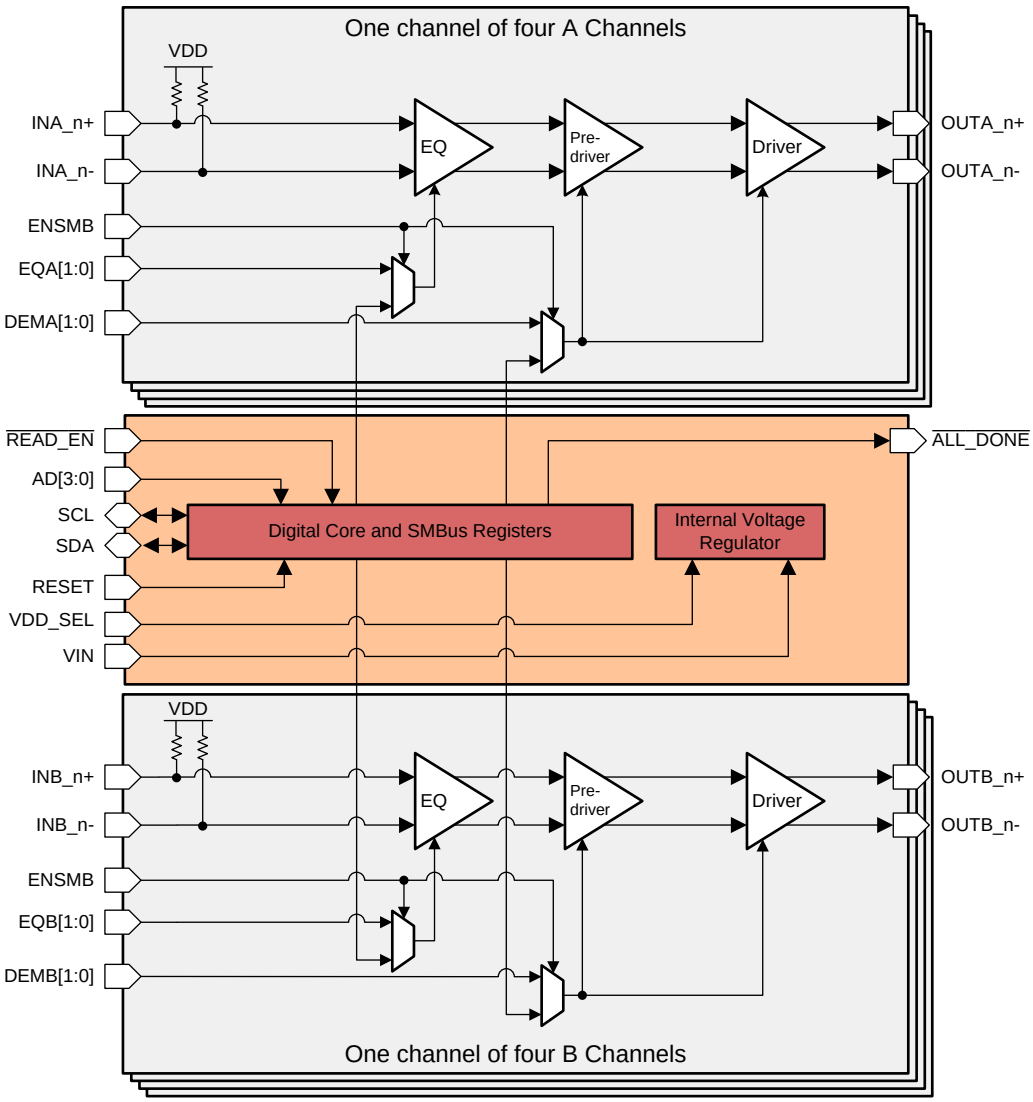
Figure 6. Output Differential Voltage (VOD = 1 Vp-p) vs Temperature

7 Detailed Description

7.1 Overview

The DS100KR800 is a low-power media compensation, 8-channel repeater optimized for 10G–KR. The DS100KR800 compensates for lossy FR-4 printed-circuit-board backplanes and balanced cables. The DS100KR800 operates in 3 modes: Pin control mode (ENSMB = 0), SMBus slave mode (ENSMB = 1) and SMBus master mode (ENSMB = float) to load register information from external EEPROM; refer to SMBUS master mode for additional information.

7.2 Functional Block Diagram



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7.3 Feature Description

7.3.1 4-Level Input Configuration Guidelines

The 4-level input pins use a resistor divider to help set the four valid control levels and provide a wider range of control settings when ENSMB = 0. There is an internal 30-kΩ pullup and a 60-kΩ pulldown connected to the package pin. These resistors, together with the external resistor connection, combine to achieve the desired voltage level. By using the 1-kΩ pulldown, 20-kΩ pulldown, no connect, and 1-kΩ pullup, the optimal voltage levels for each of the four input states are achieved as shown in Table 1.

Table 1. 4–Level Control Pin Settings

LEVEL	SETTING	RESULTING PIN VOLTAGE	
		3.3-V MODE	2.5-V MODE
0	Tie 1 kΩ to GND	0.1 V	0.08 V
R	Tie 20 kΩ to GND	1/3 x V_{IN}	1/3 x V_{DD}
F	Float (leave pin open)	2/3 x V_{IN}	2/3 x V_{DD}
1	Tie 1 kΩ to V_{IN} or V_{DD}	V_{IN} – 0.05 V	V_{DD} – 0.04 V

The typical 4-level input thresholds are as follows:

- Internal Threshold between 0 and R = 0.2 × V_{IN} or V_{DD}
- Internal Threshold between R and F = 0.5 × V_{IN} or V_{DD}
- Internal Threshold between F and 1 = 0.8 × V_{IN} or V_{DD}

In order to minimize the start-up current associated with the integrated 2.5-V regulator, the 1-kΩ pullup and pulldown resistors are recommended. If several four level inputs require the same setting, it is possible to combine two or more 1-kΩ resistors into a single lower value resistor. As an example, combining two inputs with a single 500-Ω resistor is a valid way to save board space.

7.4 Device Functional Modes

7.4.1 Pin Control Mode

When in pin mode (ENSMB = 0) , the repeater is configurable with external pins. Equalization and de-emphasis can be selected through pin for each side independently. When de-emphasis is asserted VOD is automatically adjusted per the Table 3. The receiver electrical idle detect threshold is also adjustable through the SD_TH pin.

7.4.2 SMBUS Mode

When in SMBus mode (ENSMB = 1), the VOD (output amplitude), equalization, de-emphasis, and termination disable features are all programmable on a individual lane basis, instead of grouped by A or B as in the pin mode case. Upon assertion of ENSMB the MODE, EQx and DEMx functions revert to register control immediately. The EQx and DEMx pins are converted to AD0-AD3 SMBus address inputs. The other external control pins remain active unless their respective registers are written to and the appropriate override bit is set, in which case they are ignored until ENSMB is driven low (pin mode). On power-up and when ENSMB is driven low all registers are reset to their default state. If RESET is asserted while ENSMB is high, the registers retain their current state.

Equalization settings accessible through the pin controls were chosen to meet the needs of most applications. If additional fine tuning or adjustment is needed, additional equalization settings can be accessed through the SMBus registers. Each input has a total of 256 possible equalization settings. The tables show the 16 setting when the device is in pin mode. When using SMBus mode, the equalization, VOD and de-Emphasis levels are set by registers.

The input control pins have been enhanced to have 4 different levels and provide a wider range of control settings when ENSMB=0.

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Device Functional Modes (continued)

Table 2. Equalizer Settings

LEVEL	EQA1 EQB1	EQA0 EQB0	EQ – 8 BITS [7:0]	dB AT 1 GHz	dB AT 3 GHz	dB AT 5 GHz	SUGGESTED USE
1	0	0	0000 0000 = 0x00	1.7	4.2	5.3	FR4 < 5 inch trace
2	0	R	0000 0001 = 0x01	2.8	6.6	8.7	FR4 5 inch 5–mil trace
3	0	Float	0000 0010 = 0x02	4.1	8.6	10.6	FR4 5 inch 4–mil trace
4	0	1	0000 0011 = 0x03	5.1	9.8	11.7	FR4 10 inch 5–mil trace
5	R	0	0000 0111 = 0x07	6.2	12.4	15.6	FR4 10 inch 4–mil trace
6	R	R	0001 0101 = 0x15	5.1	12	16.6	FR4 15 inch 4–mil trace
7	R	Float	0000 1011 = 0x0B	7.7	15	18.3	FR4 20 inch 4–mil trace
8	R	1	0000 1111 = 0x0F	8.8	16.5	19.7	FR4 25 to 30 inch 4–mil trace
9	Float	0	0101 0101 = 0x55	6.3	14.8	20.3	FR4 30 inch 4–mil trace
10	Float	R	0001 1111 = 0x1F	9.9	19.2	23.6	FR4 35 inch 4–mil trace
11	Float	Float	0010 1111 = 0x2F	11.3	21.7	25.8	10m, 30awg cable
12	Float	1	0011 1111 = 0x3F	12.4	23.2	27	10m – 12m cable
13	1	0	1010 1010 = 0xAA	11.9	24.1	29.1	
14	1	R	0111 1111 = 0x7F	13.6	26	30.7	
15	1	Float	1011 1111 = 0xBF	15.1	28.3	32.7	
16	1	1	1111 1111 = 0xFF	16.1	29.7	33.8	

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Table 3. De-emphasis Settings

LEVEL	DEMA1 DEMB1	DEMA0 DEMB0	VOD Vp-p	DEM dB	INNER AMPLITUDE Vp-p	SUGGESTED USE
1	0	0	0.8	0	0.8	FR4 <5 inch 4–mil trace
2	0	R	0.9	0	0.9	FR4 <5 inch 4–mil trace
3	0	Float	0.9	–3.5	0.6	FR4 10 inch 4–mil trace
4	0	1	1	0	1	FR4 <5 inch 4–mil trace
5	R	0	1	–3.5	0.7	FR4 10 inch 4–mil trace
6	R	R	1	–6	0.5	FR4 15 inch 4–mil trace
7	R	Float	1.1	0	1.1	FR4 <5 inch 4–mil trace
8	R	1	1.1	–3.5	0.7	FR4 10 inch 4–mil trace
9	Float	0	1.1	–6	0.6	FR4 15 inch 4–mil trace
10	Float	R	1.2	0	1.2	FR4 <5 inch 4–mil trace
11	Float	Float	1.2	–3.5	0.8	FR4 10 inch 4–mil trace
12	Float	1	1.2	–6	0.6	FR4 15 inch 4–mil trace
13	1	0	1.3	0	1.3	FR4 <5 inch 4–mil trace
14	1	R	1.3	–3.5	0.9	FR4 10 inch 4–mil trace
15	1	Float	1.3	–6	0.7	FR4 15 inch 4–mil trace
16	1	1	1.3	–9	0.5	FR4 20 inch 4–mil trace

Table 4. Signal Detect Threshold Level (1)

SD_TH	SMBus REG BIT [3:2] AND [1:0]	ASSERT LEVEL (TYP)	DEASSERT LEVEL (TYP)
0	10	210 mVp-p	150 mVp-p
R	01	160 mVp-p	100 mVp-p
F (default)	00	180 mVp-p	110 mVp-p
1	11	190 mVp-p	130 mVp-p

(1) Note: VDD = 2.5 V, 25°C and 0101 pattern at 8 Gbps

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7.5 Programming

7.5.1 SMBUS Master Mode

The DS100KR800 devices support reading directly from an external EEPROM device by implementing SMBus Master mode. When using the SMBus master mode, the DS100KR800 will read directly from specific location in the external EEPROM. When designing a system for using the external EEPROM, the user needs to follow these specific guidelines.

- Set ENSMB = Float — enable the SMBUS master mode.
- The external EEPROM device address byte must be 0xA0'h and capable of 1-MHz operation at 2.5-V and 3.3-V supply. The maximum allowed size is 8 kbits (1024 bytes).
- Set the AD[3:0] inputs for SMBus address byte. When the AD[3:0] = 0000'b, the device address byte is B0'h.

When tying multiple DS100KR800 devices to the SDA and SCL bus, use these guidelines to configure the devices.

- Use SMBus AD[3:0] address bits so that each device can loaded it's configuration from the EEPROM. Example below is for 4 device

  U1: AD[3:0] = 0000 = 0xB0'h,

  U2: AD[3:0] = 0001 = 0xB2'h,

  U3: AD[3:0] = 0010 = 0xB4'h,

  U4: AD[3:0] = 0011 = 0xB6'h
- Use a pullup resistor on SDA and SCL; value = 2 kΩ
- Daisy-chain READEN# (pin 26) and ALL_DONE# (pin 27) from one device to the next device in the sequence so that they do not compete for the EEPROM at the same time.
  1. Tie READEN# of the 1st device in the chain (U1) to GND
  2. Tie ALL_DONE# of U1 to READEN# of U2
  3. Tie ALL_DONE# of U2 to READEN# of U3
  4. Tie ALL_DONE# of U3 to READEN# of U4
  5. Optional: Tie ALL_DONE# output of U4 to a LED to show the devices have been loaded successfully

Below is an example of a 2 kbits (256 × 8-bit) EEPROM in hex format for the DS100KR800 device. The first 3 bytes of the EEPROM always contain a header common and necessary to control initialization of all devices connected to the I2C bus. CRC enable flag to enable/disable CRC checking. If CRC checking is disabled, a fixed pattern (8'hA5) is written or read instead of the CRC byte from the CRC location, to simplify the control. There is a MAP bit to flag the presence of an address map that specifies the configuration data start in the EEPROM. If the MAP bit is not present the configuration data start address is derived from the DS100KR800 address and the configuration data size. A bit to indicate an EEPROM size > 256 bytes is necessary to properly address the EEPROM. There are 37 bytes of data size for each DS100KR800 device.

```
:20000000000010000000407002FAD4002FAD4002FAD4002FAD409805F5A8005F5A8005F5AD0
:20002000 8005F5A800005454 0000000000000000000000000000000000000000000000F6
:20006000000000000000000000000000000000000000000000000000000000000000000080
:20008000000000000000000000000000000000000000000000000000000000000000000060
:2000A000000000000000000000000000000000000000000000000000000000000000000040
:2000C000000000000000000000000000000000000000000000000000000000000000000020
:2000E000000000000000000000000000000000000000000000000000000000000000000000
:20004000000000000000000000000000000000000000000000000000000000000000000A0
```

NOTE

The maximum EEPROM size supported is 8 kbits (1024 x 8 bits). For more information in regards to EEPROM programming and the hex format, see SNLA228.

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7.6 Register Maps

7.6.1 System Management Bus (SMBus) and Configuration Registers

The System Management Bus interface is compatible to SMBus 2.0 physical layer specification. ENSMB = 1 kΩ to VDD to enable SMBus slave mode and allow access to the configuration registers.

The DS100KR800 has the AD[3:0] inputs in SMBus mode. These pins are the user set SMBUS slave address inputs. The AD[3:0] pins have internal pulldown. When left floating or pulled low the AD[3:0] = 0000'b, the device default address byte is B0'h. Based on the SMBus 2.0 specification, the DS100KR800 has a 7-bit slave address. The LSB is set to 0'b (for a WRITE). The device supports up to 16 address byte, which can be set with the AD[3:0] inputs. Below are the 16 addresses.

Table 5. Device Slave Address Bytes

AD[3:0] SETTINGS	ADDRESS BYTES (HEX)
0000	B0
0001	B2
0010	B4
0011	B6
0100	B8
0101	BA
0110	BC
0111	BE
1000	C0
1001	C2
1010	C4
1011	C6
1100	C8
1101	CA
1110	CC
1111	CE

The SDA, SCL pins are 3.3-V tolerant, but are not 5-V tolerant. External pullup resistor is required on the SDA. The resistor value can be from 1 kΩ to 5 kΩ depending on the voltage, loading and speed. The SCL may also require an external pullup resistor and it depends on the Host that drives the bus.

7.6.1.1 Transfer of Data Through the SMBus

During normal operation the data on SDA must be stable during the time when SCL is High.

There are three unique states for the SMBus:

START: A High-to-Low transition on SDA while SCL is High indicates a message START condition.

STOP: A Low-to-High transition on SDA while SCL is High indicates a message STOP condition.

IDLE: If SCL and SDA are both High for a time exceeding t_{BUF} from the last detected STOP condition or if they are High for a total exceeding the maximum specification for t_{HIGH} then the bus will transfer to the IDLE state.

7.6.1.2 SMBus Transactions

The device supports WRITE and READ transactions. See Table 6 for register address, type (Read/Write, Read Only), default value and function information.

7.6.1.3 Writing a Register

To write a register, the following protocol is used (see SMBus 2.0 specification).

1. The Host drives a START condition, the 7-bit SMBus address, and a 0 indicating a WRITE.
2. The Device (Slave) drives the ACK bit (0).

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3. The Host drives the 8-bit Register Address.
4. The Device drives an ACK bit (0).
5. The Host drive the 8-bit data byte.
6. The Device drives an ACK bit (0).
7. The Host drives a STOP condition.

The WRITE transaction is completed, the bus goes IDLE and communication with other SMBus devices may now occur.

7.6.1.4 Reading a Register

To read a register, the following protocol is used (see SMBus 2.0 specification).

1. The Host drives a START condition, the 7-bit SMBus address, and a 0 indicating a WRITE.
2. The Device (Slave) drives the ACK bit (0).
3. The Host drives the 8-bit Register Address.
4. The Device drives an ACK bit (0).
5. The Host drives a START condition.
6. The Host drives the 7-bit SMBus Address, and a 1 indicating a READ.
7. The Device drives an ACK bit 0.
8. The Device drives the 8-bit data value (register contents).
9. The Host drives a NACK bit 1 indicating end of the READ transfer.
10. The Host drives a STOP condition.

The READ transaction is completed, the bus goes IDLE and communication with other SMBus devices may now occur.

See Table 6 for more information.

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Table 6. SMbus Register Description Table

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x00	Observation	7	Reserved	R/W	0x00		Set bit to 0
		6:3	Address Bit AD[3:0]	R			Observation of AD[3:0] bits [6]: AD3 [5]: AD2 [4]: AD1 [3]: AD0
		2	EEPROM Read Done	R			1 = Device completed the read from external EEPROM
		1	Reserved	R/W			Set bit to 0
		0	Reserved	R/W			Set bit to 0
0x01	PWDN Channels	7:0	PWDN CHx	R/W	0x00	Yes	Power Down per Channel [7]: CH7 – CHA_3 [6]: CH6 – CHA_2 [5]: CH5 – CHA_1 [4]: CH4 – CHA_0 [3]: CH3 – CHB_3 [2]: CH2 – CHB_2 [1]: CH1 – CHB_1 [0]: CH0 – CHB_0 0x00 = all channels enabled 0xFF = all channels disabled Note: Override PWDN pin and enable register control through Reg 0x02[0]
0x02	Override RESET	7	Reserved	R/W	0x00		Set bit to 0
		6	Reserved				Set bit to 0
		5:2	Reserved			Yes	Set bits to 0
		1	Reserved				Set bit to 0
		0	Override RESET			Yes	1 = Block RESET pin control (Register control enabled) 0 = Allow RESET pin control (Register control disabled)
0x03	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x04	Reserved	7:0	Reserved	R/W	0x00	Yes	Set bits to 0
0x05	Reserved	7:0	Reserved	R/W	0x00		Reserved
0x06	Slave Register Control	7:5	Reserved	R/W	0x10		Set bits to 0
		4	Reserved			Yes	Set bit to 1
		3	Register Enable				1 = Enable SMBus Slave Mode Register Control 0 = Disable SMBus Slave Mode Register Control **Note: In order to change VOD, DEM, and EQ of the channels in slave mode, this bit must be set to 1.**
		2:0	Reserved				Set bits to 0

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x07	Digital Reset and Control	7	Reserved	R/W	0x01		Set bit to 0
		6	Reset Registers				1 = Self clearing reset for SMBus registers (register settings return to default values)
		5	Reserved				Set bit to 0
		4:0	Reserved				Set bits to 0 0001'b
0x08	Override Pin Control	7	Reserved	R/W	0x00		Set bit to 0
		6	Override SD_TH			Yes	1 = Block SD_TH pin control (Register control enabled) 0 = Allow SD_TH pin control (Register control disabled)
		5:2	Reserved			Yes	Set bits to 0
		1	Override DEM			Yes	1 = Block DEM pin control (Register control enabled) 0 = Allow DEM pin control (Register control disabled)
		0	Reserved			Yes	Set bit to 0
0x09-0x0A	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x0B	Reserved	7	Reserved	R/W	0x00		Set bit to 0
		6:0	Reserved	R/W	0x70	Yes	Set bits to 111 0000'b
0x0C-0x0D	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x0E	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x0F	CH0 - CHB_0 EQ	7:0	EQ Control	R/W	0x2F	Yes	INB_0 EQ Control - total of 256 levels. See .
0x10	CH0 - CHB_0 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTB_0 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x11	CH0 - CHB_0 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTB_0 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB
0x12	CH0 - CHB_0 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x13-0x14	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x15	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x16	CH1 - CHB_1 EQ	7:0	EQ Control	R/W	0x2F	Yes	INB_1 EQ Control - total of 256 levels. See .

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x17	CH1 - CHB_1 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTB_1 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V
0x18	CH1 - CHB_1 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTB_1 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB
0x19	CH1 - CHB_1 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x1A-0x1B	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x1C	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x1D	CH2 - CHB_2 EQ	7:0	EQ Control	R/W	0x2F	Yes	INB_2 EQ Control - total of four levels. See .
0x1E	CH2 - CHB_2 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTB_2 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V
0x1F	CH2 - CHB_2 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTB_2 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x20	CH2 - CHB_2 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x21-0x22	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x23	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x24	CH3 - CHB_3 EQ	7:0	EQ Control	R/W	0x2F	Yes	INB_3 EQ Control - total of 256 levels. See .
0x25	CH3 - CHB_3 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTB_3 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x26	CH3 - CHB_3 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTB_3 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB
0x27	CH3 - CHB_3 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x28	Signal Detect Status Control	7	Reserved	R/W	0x0C		Set bit to 0
		6	Override Fast Signal Detect			Yes	Set bit to 0
		5:4	High SD_TH Status			Yes	Enable Higher Range of Signal Detect Status Thresholds [5]: CH0 - CH3 [4]: CH4 - CH7
		3:2	Fast Signal Detect Status			Yes	Enable Fast Signal Detect Status [3]: CH0 - CH3 [2]: CH4 - CH7 Note: In Fast Signal Detect, assert/deassert response occurs after approximately 3-4 ns
		1:0	Reduced SD Status Gain			Yes	Enable Reduced Signal Detect Status Gain [1]: CH0 - CH3 [0]: CH4 - CH7
0x29-0x2A	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x2B	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x2C	CH4 - CHA_0 EQ	7:0	EQ Control	R/W	0x2F	Yes	INA_0 EQ Control - total of 256 levels. See .
0x2D	CH4 - CHA_0 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTA_0 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V
0x2E	CH4 - CHA_0 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTA_0 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x2F	CH4 - CHA_0 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x30-0x31	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x32	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x33	CH5 - CHA_1 EQ	7:0	EQ Control	R/W	0x2F	Yes	INA_1 EQ Control - total of 256 levels. See .
0x34	CH5 - CHA_1 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTA_1 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x35	CH5 - CHA_1 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTA_1 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB
0x36	CH5 - CHA_1 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x37-0x38	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x39	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x3A	CH6 - CHA_2 EQ	7:0	EQ Control	R/W	0x2F	Yes	INA_2 EQ Control - total of 256 levels. See .

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x3B	CH6 - CHA_2 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTA_2 VOD Control: VOD / VID Ratio 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V
0x3C	CH6 - CHA_2 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTA_2 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB
0x3D	CH6 - CHA_2 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x3E-0x3F	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x40	Reserved	7:6	Reserved	R/W	0x00		Set bits to 0
		5:4	Reserved			Yes	Set bits to 0
		3:2	Reserved			Yes	Set bits to 0
		1:0	Reserved				Set bits to 0
0x41	CH7 - CHA_3 EQ	7:0	EQ Control	R/W	0x2F	Yes	INA_3 EQ Control - total of 256 levels. See .
0x42	CH7 - CHA_3 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1 = Enable the short circuit protection 0 = Disable the short circuit protection
		6:3	Reserved			Yes	Set bits to 0101'b
		2:0	VOD Control			Yes	OUTA_3 VOD Control: 000'b = 0.7 V 001'b = 0.8 V 010'b = 0.9 V 011'b = 1.0 V 100'b = 1.1 V 101'b = 1.2 V (default) 110'b = 1.3 V 111'b = 1.4 V
0x43	CH7 - CHA_3 DEM	7	Reserved	R	0x02		Set bit to 0
		6:5	Reserved				Set bits to 0
		4:3	Reserved	R/W			Set bits to 0
		2:0	DEM Control			Yes	OUTA_3 DEM Control 000'b = 0 dB 001'b = –1.5 dB 010'b = –3.5 dB (default) 011'b = –5 dB 100'b = –6 dB 101'b = –8 dB 110'b = –9 dB 111'b = –12 dB

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Table 6. SMbus Register Description Table (continued)

ADDRESS	REGISTER NAME	BIT	FIELD	TYPE	DEFAULT	EEPROM REG BIT	DESCRIPTION
0x44	CH7 - CHA_3 SD_TH	7	Reserved	R/W	0x00	Yes	Set bit to 0
		6:4	Reserved				Set bits to 0
		3:2	Signal Detect Status Assert Threshold			Yes	Status Assert threshold 00'b = 180 mVp-p (default) 01'b = 160 mVp-p 10'b = 210 mVp-p 11'b = 190 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
		1:0	Signal Detect Status Deassert Threshold			Yes	Status Deassert threshold 00'b = 110 mVp-p (default) 01'b = 100 mVp-p 10'b = 150 mVp-p 11'b = 130 mVp-p Note: Override SD_TH pin and enable register control through Reg 0x08[6]
0x45	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x46	Reserved	7:0	Reserved	R/W	0x38		Set bits to 0x38
0x47	Reserved	7:4	Reserved	R/W	0x00		Set bits to 0
		3:0	Reserved			Yes	Set bits to 0
0x48	Reserved	7:6	Reserved	R/W	0x05	Yes	Set bits to 0
		5:0	Reserved	R/W			Set bits to 00 0101'b
0x49-0x4B	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x4C	Reserved	7:3	Reserved	R/W	0x00	Yes	Set bits to 0
		2:1	Reserved	R/W			Set bits to 0
		0	Reserved	R/W		Yes	Set bits to 0
0x4D-0x50	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x51	Device ID	7:5	VERSION	R	0x45		010'b
		4:0	ID				0 0101'b
0x52-0x55	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x56	Reserved	7:0	Reserved	R/W	0x10		Set bits to 0x10
0x57	Reserved	7:0	Reserved	R/W	0x64		Set bits to 0x64
0x58	Reserved	7:0	Reserved	R/W	0x21		Set bits to 0x21
0x59	Reserved	7:1	Reserved	R/W	0x00		Set bits to 0
		0	Reserved			Yes	Set bit to 0
0x5A	Reserved	7:0	Reserved	R/W	0x54	Yes	Set bits to 0x54
0x5B	Reserved	7:0	Reserved	R/W	0x54	Yes	Set bits to 0x54
0x5C-0x61	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0

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Table 7. EEPROM Register Map - Single Device With Default Value

EEPROM ADDRESS BYTE			BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Description		0x00	CRC_EN	Address Map Present	EEPROM > 256 Bytes	Reserved	DEVICE COUNT[3]	DEVICE COUNT[2]	DEVICE COUNT[1]	DEVICE COUNT[0]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x01	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x02	Max EEPROM Burst size[7]	Max EEPROM Burst size[6]	Max EEPROM Burst size[5]	Max EEPROM Burst size[4]	Max EEPROM Burst size[3]	Max EEPROM Burst size[2]	Max EEPROM Burst size[1]	Max EEPROM Burst size[0]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x03	PWDN_CH7	PWDN_CH6	PWDN_CH5	PWDN_CH4	PWDN_CH3	PWDN_CH2	PWDN_CH1	PWDN_CH0
SMBus Register			0x01[7]	0x01[6]	0x01[5]	0x01[4]	0x01[3]	0x01[2]	0x01[1]	0x01[0]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x04	Reserved	Reserved	Reserved	Reserved	Ovrd_RESET	Reserved	Reserved	Reserved
SMBus Register			0x02[5]	0x02[4]	0x02[3]	0x02[2]	0x02[0]	0x04[7]	0x04[6]	0x04[5]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x05	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Ovrd_SD_TH	Reserved
SMBus Register			0x04[4]	0x04[3]	0x04[2]	0x04[1]	0x04[0]	0x06[4]	0x08[6]	0x08[5]
Default Value	0x04		0	0	0	0	0	1	0	0
Description		0x06	Reserved	Reserved	Reserved	Ovrd_DEM	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x08[4]	0x08[3]	0x08[2]	0x08[1]	0x08[0]	0x0B[6]	0x0B[5]	0x0B[4]
Default Value	0x07		0	0	0	0	0	1	1	1
Description		0x07	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x0B[3]	0x0B[2]	0x0B[1]	0x0B[0]	0x0E[5]	0x0E[4]	0x0E[3]	0x0E[2]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x08	CH0_EQ_7	CH0_EQ_6	CH0_EQ_5	CH0_EQ_4	CH0_EQ_3	CH0_EQ_2	CH0_EQ_1	CH0_EQ_0
SMBus Register			0x0F[7]	0x0F[6]	0x0F[5]	0x0F[4]	0x0F[3]	0x0F[2]	0x0F[1]	0x0F[0]
Default Value	0x2F		0	0	1	0	1	1	1	1

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Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM ADDRESS BYTE			BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Description		0x09	CH0_SCP	Reserved	Reserved	Reserved	Reserved	CH0_VOD_2	CH0_VOD_1	CH0_VOD_0
SMBus Register			0x10[7]	0x10[6]	0x10[5]	0x10[4]	0x10[3]	0x10[2]	0x10[1]	0x10[0]
Default Value	0xAD		1	0	1	0	1	1	0	1
Description		0x0A	CH0_DEM_2	CH0_DEM_1	CH0_DEM_0	Reserved	CH0_THa_1	CH0_THa_0	CH0_THd_1	CH0_THd_0
SMBus Register			0x11[2]	0x11[1]	0x11[0]	0x12[7]	0x12[3]	0x12[2]	0x12[1]	0x12[0]
Default Value	0x40		0	1	0	0	0	0	0	0
Description		0x0B	Reserved	Reserved	Reserved	Reserved	CH1_EQ_7	CH1_EQ_6	CH1_EQ_5	CH1_EQ_4
SMBus Register			0x15[5]	0x15[4]	0x15[3]	0x15[2]	0x16[7]	0x16[6]	0x16[5]	0x16[4]
Default Value	0x02		0	0	0	0	0	0	1	0
Description		0x0C	CH1_EQ_3	CH1_EQ_2	CH1_EQ_1	CH1_EQ_0	CH1_SCP	Reserved	Reserved	Reserved
SMBus Register			0x16[3]	0x16[2]	0x16[1]	0x16[0]	0x17[7]	0x17[6]	0x17[5]	0x17[4]
Default Value	0xFA		1	1	1	1	1	0	1	0
Description		0x0D	Reserved	CH1_VOD_2	CH1_VOD_1	CH1_VOD_0	CH1_DEM_2	CH1_DEM_1	CH1_DEM_0	Reserved
SMBus Register			0x17[3]	0x17[2]	0x17[1]	0x17[0]	0x18[2]	0x18[1]	0x18[0]	0x19[7]
Default Value	0xD4		1	1	0	1	0	1	0	0
Description		0x0E	CH1_THa_1	CH1_THa_0	CH1_THd_1	CH1_THd_0	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x19[3]	0x19[2]	0x19[1]	0x19[0]	0x1C[5]	0x1C[4]	0x1C[3]	0x1C[2]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x0F	CH2_EQ_7	CH2_EQ_6	CH2_EQ_5	CH2_EQ_4	CH2_EQ_3	CH2_EQ_2	CH2_EQ_1	CH2_EQ_0
SMBus Register			0x1D[7]	0x1D[6]	0x1D[5]	0x1D[4]	0x1D[3]	0x1D[2]	0x1D[1]	0x1D[0]
Default Value	0x2F		0	0	1	0	1	1	1	1
Description		0x10	CH2_SCP	Reserved	Reserved	Reserved	Reserved	CH2_VOD_2	CH2_VOD_1	CH2_VOD_0
SMBus Register			0x1E[7]	0x1E[6]	0x1E[5]	0x1E[4]	0x1E[3]	0x1E[2]	0x1E[1]	0x1E[0]
Default Value	0xAD		1	0	1	0	1	1	0	1
Description		0x11	CH2_DEM_2	CH2_DEM_1	CH2_DEM_0	Reserved	CH2_THa_1	CH2_THa_0	CH2_THd_1	CH2_THd_0
SMBus Register			0x1F[2]	0x1F[1]	0x1F[0]	0x20[7]	0x20[3]	0x20[2]	0x20[1]	0x20[0]
Default Value	0x40		0	1	0	0	0	0	0	0

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Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM ADDRESS BYTE			BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Description		0x12	Reserved	Reserved	Reserved	Reserved	CH3_EQ_7	CH3_EQ_6	CH3_EQ_5	CH3_EQ_4
SMBus Register			0x23[5]	0x23[4]	0x23[3]	0x23[2]	0x24[7]	0x24[6]	0x24[5]	0x24[4]
Default Value	0x02		0	0	0	0	0	0	1	0
Description		0x13	CH3_EQ_3	CH3_EQ_2	CH3_EQ_1	CH3_EQ_0	CH3_SCP	Reserved	Reserved	Reserved
SMBus Register			0x24[3]	0x24[2]	0x24[1]	0x24[0]	0x25[7]	0x25[6]	0x25[5]	0x25[4]
Default Value	0xFA		1	1	1	1	1	0	1	0
Description		0x14	Reserved	CH3_VOD_2	CH3_VOD_1	CH3_VOD_0	CH3_DEM_2	CH3_DEM_1	CH3_DEM_0	Reserved
SMBus Register			0x25[3]	0x25[2]	0x25[1]	0x25[0]	0x26[2]	0x26[1]	0x26[0]	0x27[7]
Default Value	0xD4		1	1	0	1	0	1	0	0
Description		0x15	CH3_THa_1	CH3_THa_0	CH3_THd_1	CH3_THd_0	ovrd_fast_SD	hi_idle_SD CH0-3	hi_idle_SD CH4-7	fast_SD CH0-3
SMBus Register			0x27[3]	0x27[2]	0x27[1]	0x27[0]	0x28[6]	0x28[5]	0x28[4]	0x28[3]
Default Value	0x01		0	0	0	0	0	0	0	1
Description		0x16	fast_SD CH4-7	lo_gain_SD CH0-3	lo_gain_SD CH4-7	Reserved	Reserved	Reserved	Reserved	CH4_EQ_7
SMBus Register			0x28[2]	0x28[1]	0x28[0]	0x2B[5]	0x2B[4]	0x2B[3]	0x2B[2]	0x2C[7]
Default Value	0x80		1	0	0	0	0	0	0	0
Description		0x17	CH4_EQ_6	CH4_EQ_5	CH4_EQ_4	CH4_EQ_3	CH4_EQ_2	CH4_EQ_1	CH4_EQ_0	CH4_SCP
SMBus Register			0x2C[6]	0x2C[5]	0x2C[4]	0x2C[3]	0x2C[2]	0x2C[1]	0x2C[0]	0x2D[7]
Default Value	0x5F		0	1	0	1	1	1	1	1
Description		0x18	Reserved	Reserved	Reserved	Reserved	CH4_VOD_2	CH4_VOD_1	CH4_VOD_0	CH4_DEM_2
SMBus Register			0x2D[6]	0x2D[5]	0x2D[4]	0x2D[3]	0x2D[2]	0x2D[1]	0x2D[0]	0x2E[2]
Default Value	0x5A		0	1	0	1	1	0	1	0
Description		0x19	CH4_DEM_1	CH4_DEM_0	Reserved	CH4_THa_1	CH4_THa_0	CH4_THd_1	CH4_THd_0	Reserved
SMBus Register			0x2E[1]	0x2E[0]	0x2F[7]	0x2F[3]	0x2F[2]	0x2F[1]	0x2F[0]	0x32[5]
Default Value	0x80		1	0	0	0	0	0	0	0
Description		0x1A	Reserved	Reserved	Reserved	CH5_EQ_7	CH5_EQ_6	CH5_EQ_5	CH5_EQ_4	CH5_EQ_3
SMBus Register			0x32[4]	0x32[3]	0x32[2]	0x33[7]	0x33[6]	0x33[5]	0x33[4]	0x33[3]
Default Value	0x05		0	0	0	0	0	1	0	1

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Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM ADDRESS BYTE			BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Description		0x1B	CH5_EQ_2	CH5_EQ_1	CH5_EQ_0	CH5_SCP	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x33[2]	0x33[1]	0x33[0]	0x34[7]	0x34[6]	0x34[5]	0x34[4]	0x34[3]
Default Value	0xF5		1	1	1	1	0	1	0	1
Description		0x1C	CH5_VOD_2	CH5_VOD_1	CH5_VOD_0	CH5_DEM_2	CH5_DEM_1	CH5_DEM_0	Reserved	CH5_THa_1
SMBus Register			0x34[2]	0x34[1]	0x34[0]	0x35[2]	0x35[1]	0x35[0]	0x36[7]	0x36[3]
Default Value	0xA8		1	0	1	0	1	0	0	0
Description		0x1D	CH5_THa_0	CH5_THd_1	CH5_THd_0	Reserved	Reserved	Reserved	Reserved	CH6_EQ_7
SMBus Register			0x36[2]	0x36[1]	0x36[0]	0x39[5]	0x39[4]	0x39[3]	0x39[2]	0x3A[7]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x1E	CH6_EQ_6	CH6_EQ_5	CH6_EQ_4	CH6_EQ_3	CH6_EQ_2	CH6_EQ_1	CH6_EQ_0	CH6_SCP
SMBus Register			0x3A[6]	0x3A[5]	0x3A[4]	0x3A[3]	0x3A[2]	0x3A[1]	0x3A[0]	0x3B[7]
Default Value	0x5F		0	1	0	1	1	1	1	1
Description		0x1F	Reserved	Reserved	Reserved	Reserved	CH6_VOD_2	CH6_VOD_1	CH6_VOD_0	CH6_DEM_2
SMBus Register			0x3B[6]	0x3B[5]	0x3B[4]	0x3B[3]	0x3B[2]	0x3B[1]	0x3B[0]	0x3C[2]
Default Value	0x5A		0	1	0	1	1	0	1	0
Description		0x20	CH6_DEM_1	CH6_DEM_0	Reserved	CH6_THa_1	CH6_THa_0	CH6_THd_1	CH6_THd_0	Reserved
SMBus Register			0x3C[1]	0x3C[0]	0x3D[7]	0x3D[3]	0x3D[2]	0x3D[1]	0x3D[0]	0x40[5]
Default Value	0x80		1	0	0	0	0	0	0	0
Description		0x21	Reserved	Reserved	Reserved	CH7_EQ_7	CH7_EQ_6	CH7_EQ_5	CH7_EQ_4	CH7_EQ_3
SMBus Register			0x40[4]	0x40[3]	0x40[2]	0x41[7]	0x41[6]	0x41[5]	0x41[4]	0x41[3]
Default Value	0x05		0	0	0	0	0	1	0	1
Description		0x22	CH7_EQ_2	CH7_EQ_1	CH7_EQ_0	CH7_SCP	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x41[2]	0x41[1]	0x41[0]	0x42[7]	0x42[6]	0x42[5]	0x42[4]	0x42[3]
Default Value	0xF5		1	1	1	1	0	1	0	1
Description		0x23	CH7_VOD_2	CH7_VOD_1	CH7_VOD_0	CH7_DEM_2	CH7_DEM_1	CH7_DEM_0	Reserved	CH7_THa_1
SMBus Register			0x42[2]	0x42[1]	0x42[0]	0x43[2]	0x43[1]	0x43[0]	0x44[7]	0x44[3]
Default Value	0xA8		1	0	1	0	1	0	0	0

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Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM ADDRESS BYTE			BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Description		0x24	CH7_THa_0	CH7_THd_1	CH7_THd_0	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x44[2]	0x44[1]	0x44[0]	0x47[3]	0x47[2]	0x47[1]	0x47[0]	0x48[7]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x25	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x48[6]	0x4C[7]	0x4C[6]	0x4C[5]	0x4C[4]	0x4C[3]	0x4C[0]	0x59[0]
Default Value	0x00		0	0	0	0	0	0	0	0
Description		0x26	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x5A[7]	0x5A[6]	0x5A[5]	0x5A[4]	0x5A[3]	0x5A[2]	0x5A[1]	0x5A[0]
Default Value	0x54		0	1	0	1	0	1	0	0
Description		0x27	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register			0x5B[7]	0x5B[6]	0x5B[5]	0x5B[4]	0x5B[3]	0x5B[2]	0x5B[1]	0x5B[0]
Default Value	0x54		0	1	0	1	0	1	0	0

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Table 8. Example of EEPROM for 4 Devices Using 2 Address Maps(1)

EEPROM ADDRESS	ADDRESS (HEX)	EEPROM DATA	COMMENTS
0	00	0x43	CRC_EN = 0, Address Map = 1, >256 bytes = 0, Device Count[3:0] = 3
1	01	0x00	
2	02	0x08	EEPROM Burst Size
3	03	0x00	CRC not used
4	04	0x0B	Device 0 Address Location
5	05	0x00	CRC not used
6	06	0x0B	Device 1 Address Location
7	07	0x00	CRC not used
8	08	0x30	Device 2 Address Location
9	09	0x00	CRC not used
10	0A	0x30	Device 3 Address Location
11	0B	0x00	Begin Device 0, 1 - Address Offset 3
12	0C	0x00	
13	0D	0x04	
14	0E	0x07	
15	0F	0x00	
16	10	0x00	EQ CHB0 = 00
17	11	0xAB	VOD CHB0 = 1.0 V
18	12	0x00	DEM CHB0 = 0 (0 dB)
19	13	0x00	EQ CHB1 = 00
20	14	0x0A	VOD CHB1 = 1.0 V
21	15	0xB0	DEM CHB1 = 0 (0 dB)
22	16	0x00	
23	17	0x00	EQ CHB2 = 00
24	18	0xAB	VOD CHB2 = 1.0 V
25	19	0x00	DEM CHB2 = 0 (0 dB)
26	1A	0x00	EQ CHB3 = 00
27	1B	0x0A	VOD CHB3 = 1.0 V
28	1C	0xB0	DEM CHB3 = 0 (0 dB)
29	1D	0x01	
30	1E	0x80	
31	1F	0x01	EQ CHA0 = 00
32	20	0x56	VOD CHA0 = 1.0 V
33	21	0x00	DEM CHA0 = 0 (0 dB)
34	22	0x00	EQ CHA1 = 00
35	23	0x15	VOD CHA1 = 1.0 V
36	24	0x60	DEM CHA1 = 0 (0 dB)
37	25	0x00	
38	26	0x01	EQ CHA2 = 00
39	27	0x56	VOD CHA2 = 1.0 V
40	28	0x00	DEM CHA2 = 0 (0 dB)
41	29	0x00	EQ CHA3 = 00
42	2A	0x15	VOD CHA3 = 1.0 V
43	2B	0x60	DEM CHA3 = 0 (0 dB)
44	2C	0x00	

(1) Note: CRC_EN = 0, Address Map = 1, >256 byte = 0, Device Count[3:0] = 3. This example has all 8–channels set to EQ = 00 (min boost), VOD = 1.0 V, DEM = 0 (0 dB) and multiple device can point to the same address map.

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Table 8. Example of EEPROM for 4 Devices Using 2 Address Maps(1) (continued)

EEPROM ADDRESS	ADDRESS (HEX)	EEPROM DATA	COMMENTS
45	2D	0x00	
46	2E	0x54	
47	2F	0x54	End Device 0, 1 - Address Offset 39
48	30	0x00	Begin Device 2, 3 - Address Offset 3
49	31	0x00	
50	32	0x04	
51	33	0x07	
52	34	0x00	
53	35	0x00	EQ CHB0 = 00
54	36	0xAB	VOD CHB0 = 1.0 V
55	37	0x00	DEM CHB0 = 0 (0 dB)
56	38	0x00	EQ CHB1 = 00
57	39	0x0A	VOD CHB1 = 1.0 V
58	3A	0xB0	DEM CHB1 = 0 (0 dB)
59	3B	0x00	
60	3C	0x00	EQ CHB2 = 00
61	3D	0xAB	VOD CHB2 = 1.0 V
62	3E	0x00	DEM CHB2 = 0 (0 dB)
63	3F	0x00	EQ CHB3 = 00
64	40	0x0A	VOD CHB3 = 1.0 V
65	41	0xB0	DEM CHB3 = 0 (0 dB)
66	42	0x01	
67	43	0x80	
68	44	0x01	EQ CHA0 = 00
69	45	0x56	VOD CHA0 = 1.0 V
70	46	0x00	DEM CHA0 = 0 (0 dB)
71	47	0x00	EQ CHA1 = 00
72	48	0x15	VOD CHA1 = 1.0 V
73	49	0x60	DEM CHA1 = 0 (0 dB)
74	4A	0x00	
75	4B	0x01	EQ CHA2 = 00
76	4C	0x56	VOD CHA2 = 1.0 V
77	4D	0x00	DEM CHA2 = 0 (0 dB)
78	4E	0x00	EQ CHA3 = 00
79	4F	0x15	VOD CHA3 = 1.0 V
80	50	0x60	DEM CHA3 = 0 (0 dB)
81	51	0x00	
82	52	0x00	
83	53	0x54	
84	54	0x54	End Device 2, 3 - Address Offset 39

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8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The DS100KR800 is a high-performance circuit capable of delivering excellent performance. Pay careful attention to the details associated with high-speed design as well as providing a clean power supply. Refer to the information below and Revision 4 of the LVDS Owner's Manual for more detailed information on high-speed design tips to address signal integrity design issues.

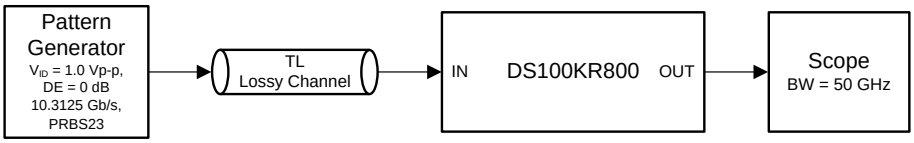


Figure 7. Test Set-Up Connections Diagram



Figure 8. Test Set-Up Connections Diagram

8.2 Typical Application

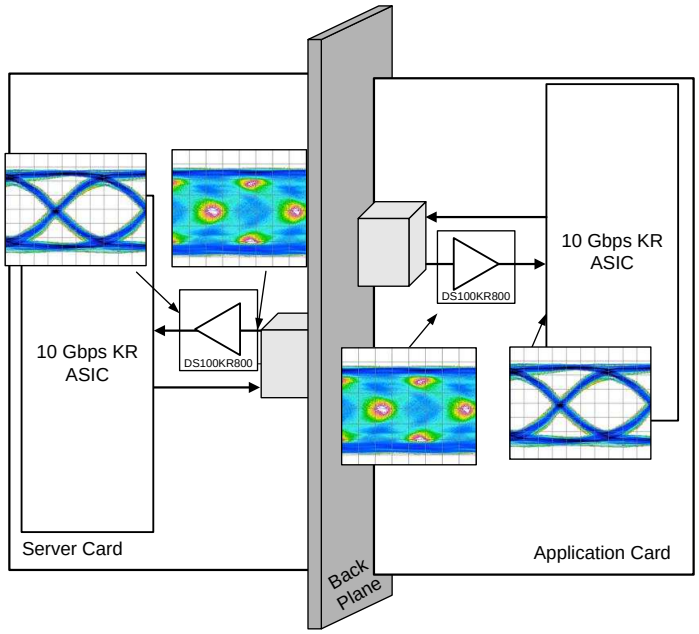


Figure 9. Ethernet Backplane

Typical Application (continued)

8.2.1 Design Requirements

As with any high-speed design, there are many factors which influence the overall performance. Below are a list of critical areas for consideration and study during design.

- Use 100-Ω impedance traces. Generally these are very loosely coupled to ease routing length differences.
- Place AC-coupling capacitors near to the receiver end of each channel segment to minimize reflections.
- The maximum body size for AC-coupling capacitors is 0402.
- Back-drill connector vias and signal vias to minimize stub length.
- Use Reference plane vias to ensure a low inductance path for the return current.

8.2.2 Detailed Design Procedure

The DS100KR800 is designed to be placed at an offset location with respect to the overall channel attenuation. In order to optimize performance, the repeater requires tuning to extend the reach of the cable or trace length while also recovering a solid eye opening. To tune the repeater, the settings mentioned in Table 2 and Table 3 are recommended as a default starting point for most applications. Once these settings are configured, additional tuning of the EQ and, to a lesser extent, VOD may be required to optimize the repeater performance for each specific application environment.

Examples of the repeater performance as a generic high-speed datapath repeater are shown in the performance curves in the *Application Curves*.

8.2.3 Application Curves

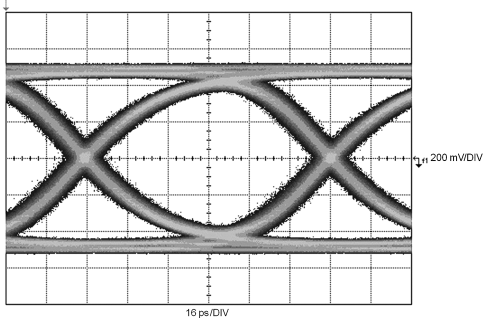


Figure 10. TL = 20 inch 4–mil FR4 Trace, DS100KR800 Settings: EQ[1:0] = R, R = 15'h, DEM[1:0] = Float, Float

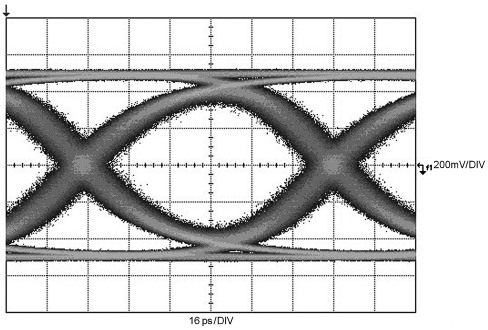


Figure 11. TL = 30 inch 4–mil FR4 Trace, DS100KR800 Settings: EQ[1:0] = Float, R = 1F'h, DEM[1:0] = Float, Float

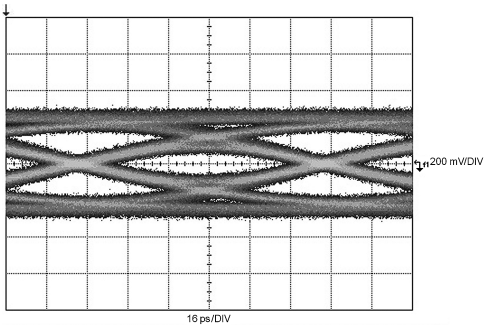


Figure 12. TL1 = 20 inch 4–mil FR4 Trace, TL2 = 15 inch 4–mil FR4 Trace, DS100KR800 Settings: EQ[1:0] = R, R = 15'h, DEM[1:0] = Float, Float

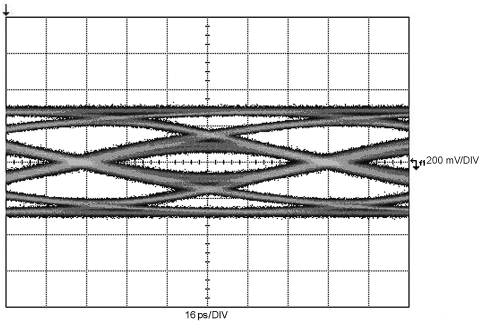


Figure 13. TL1 = 30 inch 4–mil FR4 Trace, TL2 = 15 Inch 4–mil FR4 Trace, DS100KR800 Settings: EQ[1:0] = Float, R = 1F'h, DEM[1:0] = Float, Float

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9 Power Supply Recommendations

9.1 3.3-V or 2.5-V Supply Mode Operation

The DS1000KR800 has an optional internal voltage regulator to provide the 2.5-V supply to the device. In 3.3-V mode, the VIN pin = 3.3 V is used to supply power to the device and the VDD pins should be left open. The internal regulator will provide the 2.5 V to the VDD pins of the device and a 0.1-µF capacitor is needed at each of the five VDD pins for power supply de-coupling (total capacitance should be ≤ 0.5 µF), and the VDD pins should be left open. The VDD_SEL pin must be tied to GND to enable the internal regulator. In 2.5-V mode, the VIN pin should be left open and 2.5-V supply must be applied to the VDD pins. The VDD_SEL pin must be left open (no connect) to disable the internal regulator.

The DS100KR800 can be configured for 2.5-V operation or 3.3-V operation. The lists below outline required connections for each supply selection.

For 3.3-V mode of operation, use the following steps:

1. Tie VDD_SEL = 0 with 1-kΩ resistor to GND.
2. Feed 3.3-V supply into VIN pin. Local 1.0-µF decoupling at VIN is recommended.
3. See information on VDD bypass below.
4. SDA and SCL pins should connect pullup resistor to VIN
5. Any 4-Level input which requires a connection to Logic 1 should use a 1-kΩ resistor to VIN

For 2.5-V mode of operation, use the following steps:

1. VDD_SEL = Float
2. VIN = Float
3. Feed 2.5-V supply into VDD pins.
4. See information on VDD bypass below.
5. SDA and SCL pins connect pullup resistor to VDD for 2.5-V uC SMBus IO
6. SDA and SCL pins connect pullup resistor to VDD for 3.3-V uC SMBus IO
7. Any 4-Level input which requires a connection to Logic 1 should use a 1-kΩ resistor to VDD

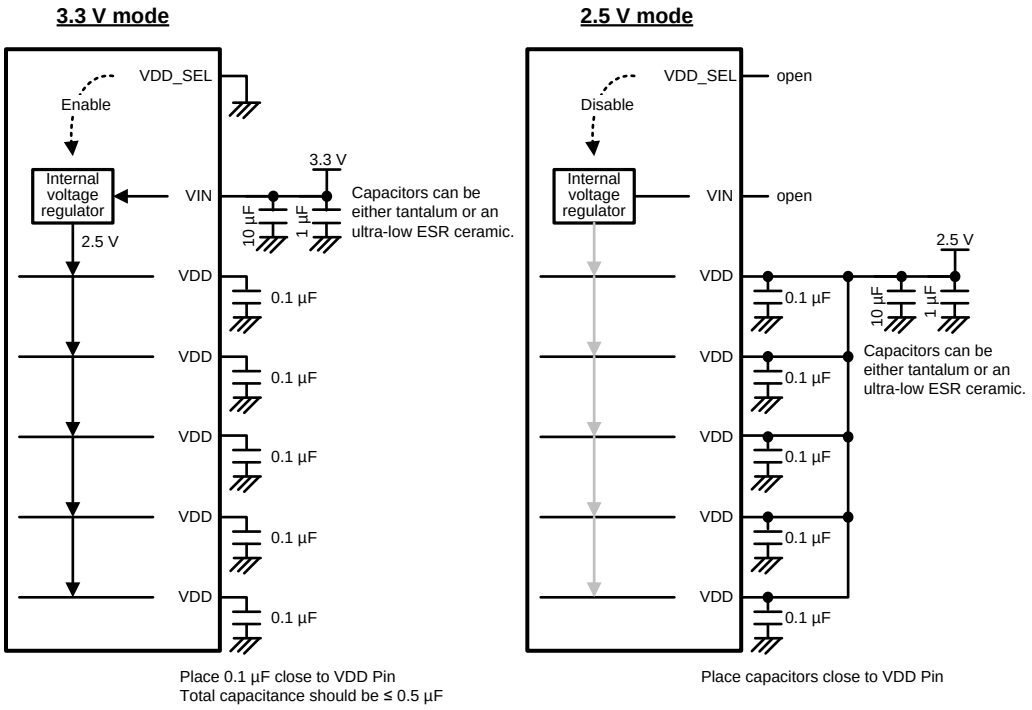


Figure 14. 3.3-V or 2.5-V Supply Connection Diagram

9.2 Power Supply Bypassing

Two approaches are recommended to ensure that the DS100KR800 is provided with an adequate power supply bypass. First, the supply (V_{DD}) and ground (GND) pins should be connected to power planes routed on adjacent layers of the printed-circuit-board. Second, pay careful attention to supply bypassing through the proper use of bypass capacitors is required. A 0.1-µF bypass capacitor should be connected to each V_{DD} pin such that the capacitor is placed as close as possible to the device. Small body size capacitors (such as 0402) reduce the parasitic inductance of the capacitor and also help in placement close to the V_{DD} pin. If possible, the layer thickness of the dielectric should be minimized so that the V_{DD} and GND planes create a low inductance supply with distributed capacitance.

10 Layout

10.1 Layout Guidelines

The differential inputs and outputs are designed with 100-Ω differential terminations. Therefore, they should be connected to interconnects with controlled differential impedance of approximately 85-110 Ω. It is preferable to route differential lines primarily on one layer of the board, particularly for the input traces. The use of vias should be avoided if possible. If vias must be used, they should be used sparingly and must be placed symmetrically for each side of a given differential pair. Whenever differential vias are used, the layout must also provide for a low inductance path for the return currents as well. Route the differential signals away from other signals and noise sources on the printed-circuit-board. To minimize the effects of crosstalk, a 5:1 ratio or greater should be maintained between inter-pair spacing and trace width. See *AN-1187 Leadless Leadframe Package (LLP)* Application Report (SNOA401) for additional information on QFN (WQFN) packages.

The DS100KR800 pinout promotes easy high-speed routing and layout. To optimize DS100KR800 performance refer to the following guidelines:

1. Place local VIN and VDD capacitors as close as possible to the device supply pins. Often the best location is directly under the DS100KR800 pins to reduce the inductance path to the capacitor. In addition, bypass capacitors may share a via with the DAP GND to minimize ground loop inductance.
2. Differential pairs going into or out of the DS100KR800 should have adequate pair-to-pair spacing to minimize crosstalk.
3. Use return current via connections to link reference planes locally. This ensures a low inductance return current path when the differential signal changes layers.
4. Optimize the via structure to minimize trace impedance mismatch.
5. Place GND vias around the DAP perimeter to ensure optimal electrical and thermal performance.
6. Use small body size AC-coupling capacitors when possible — 0402 or smaller size is preferred. The AC-coupling capacitors should be placed closer to the Rx on the channel.

Figure 15 depicts different transmission line topologies which can be used in various combinations to achieve the optimal system performance. Impedance discontinuities at the differential via can be minimized or eliminated by increasing the swell around each hole and providing for a low inductance return current path. When the via structure is associated with thick backplane PCB, further optimization such as back drilling is often used to reduce the detrimental high-frequency effects of stubs on the signal path.

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10.2 Layout Example

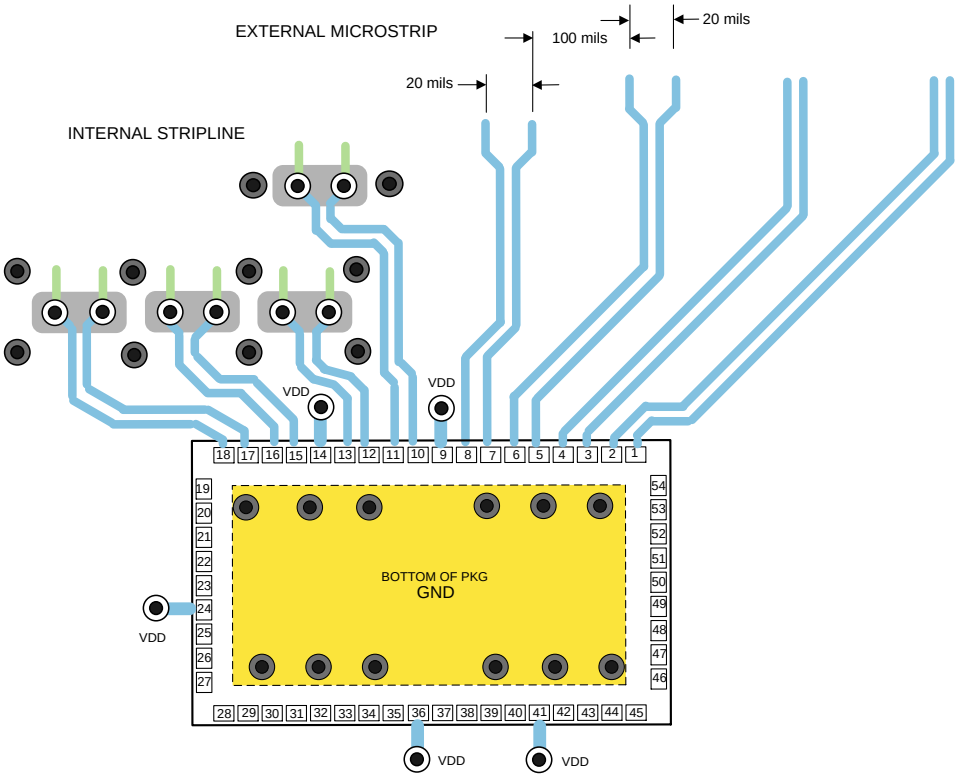


Figure 15. Typical Routing Options

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation, see the following:

- *Absolute Maximum Ratings for Soldering* (SNOA549)
- *Understanding EEPROM Programming for High Speed Repeaters and Mux Buffers* (SNLA228)
- AN-1187 *Leadless Leadframe Package (LLP) Application Report* (SNOA401)

11.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community ***TI's Engineer-to-Engineer (E2E) Community.*** Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support ***TI's Design Support*** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.3 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

11.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.5 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
DS100KR800SQ/NOPB	Active	Production	WQFN (NJY) | 54	2000 | LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS100KR800SQ
DS100KR800SQ/NOPB.A	Active	Production	WQFN (NJY) | 54	2000 | LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS100KR800SQ
DS100KR800SQ/NOPB.B	Active	Production	WQFN (NJY) | 54	2000 | LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS100KR800SQ
DS100KR800SQE/NOPB	Active	Production	WQFN (NJY) | 54	250 | SMALL T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS100KR800SQ
DS100KR800SQE/NOPB.A	Active	Production	WQFN (NJY) | 54	250 | SMALL T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS100KR800SQ
DS100KR800SQE/NOPB.B	Active	Production	WQFN (NJY) | 54	250 | SMALL T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS100KR800SQ

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

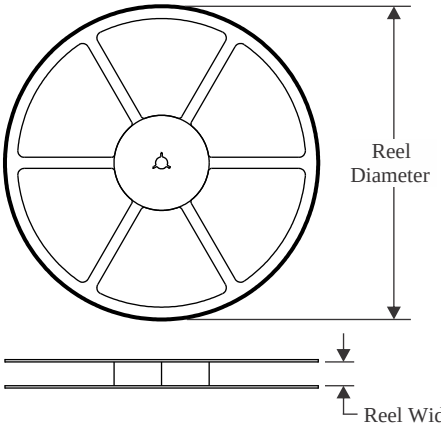
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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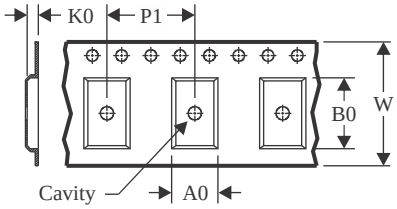
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

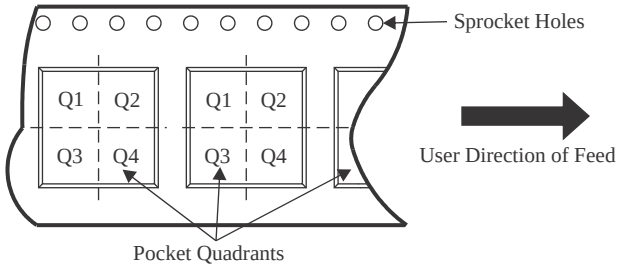


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

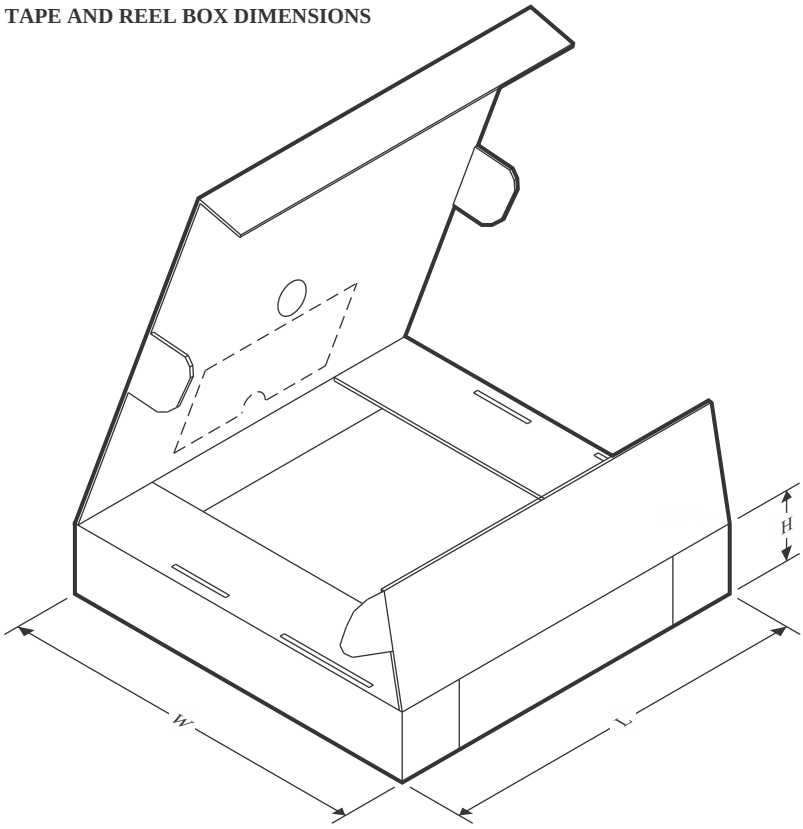
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

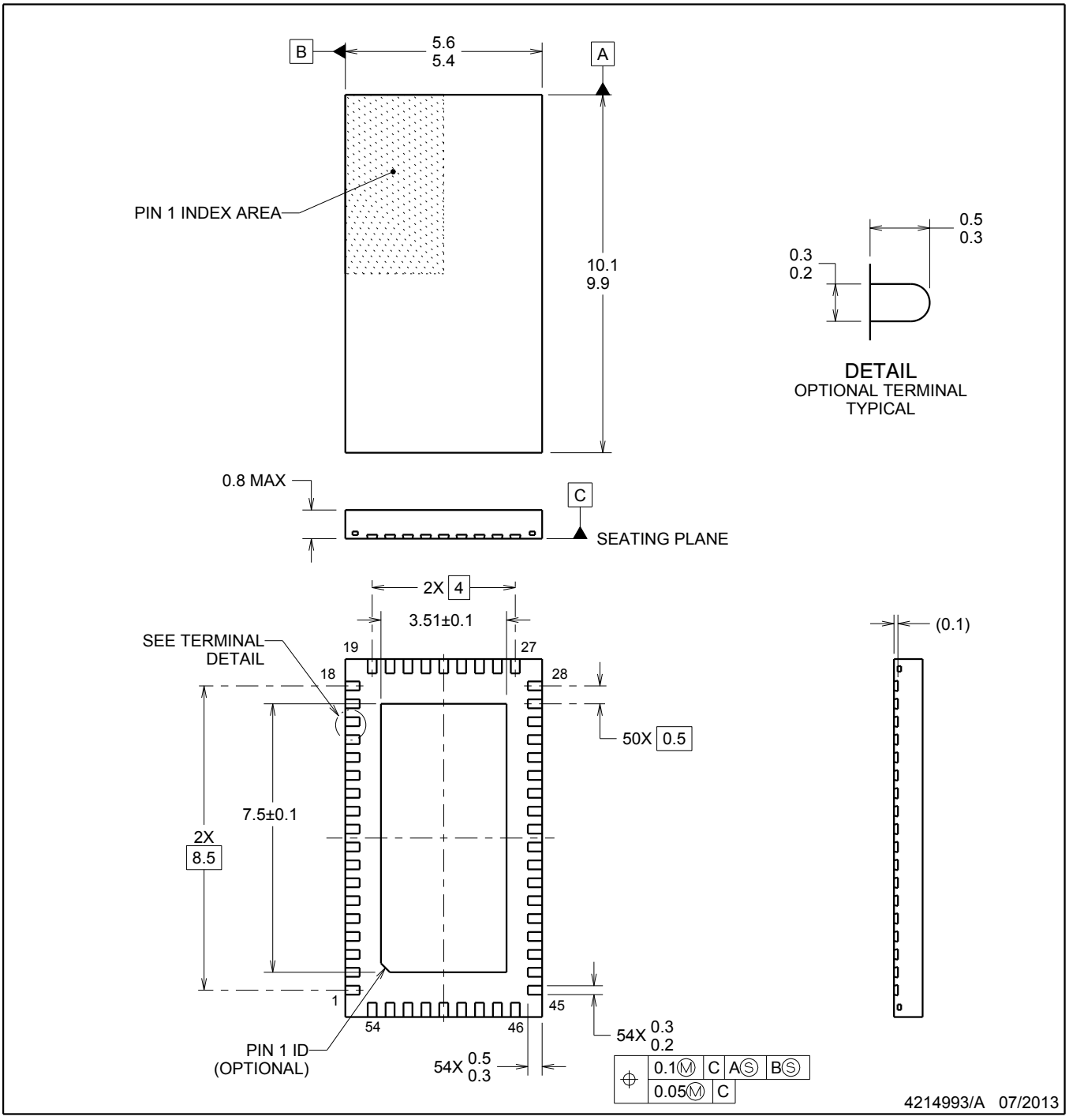
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS100KR800SQ/NOPB	WQFN	NJY	54	2000	330.0	16.4	5.8	10.3	1.0	12.0	16.0	Q1
DS100KR800SQE/NOPB	WQFN	NJY	54	250	178.0	16.4	5.8	10.3	1.0	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



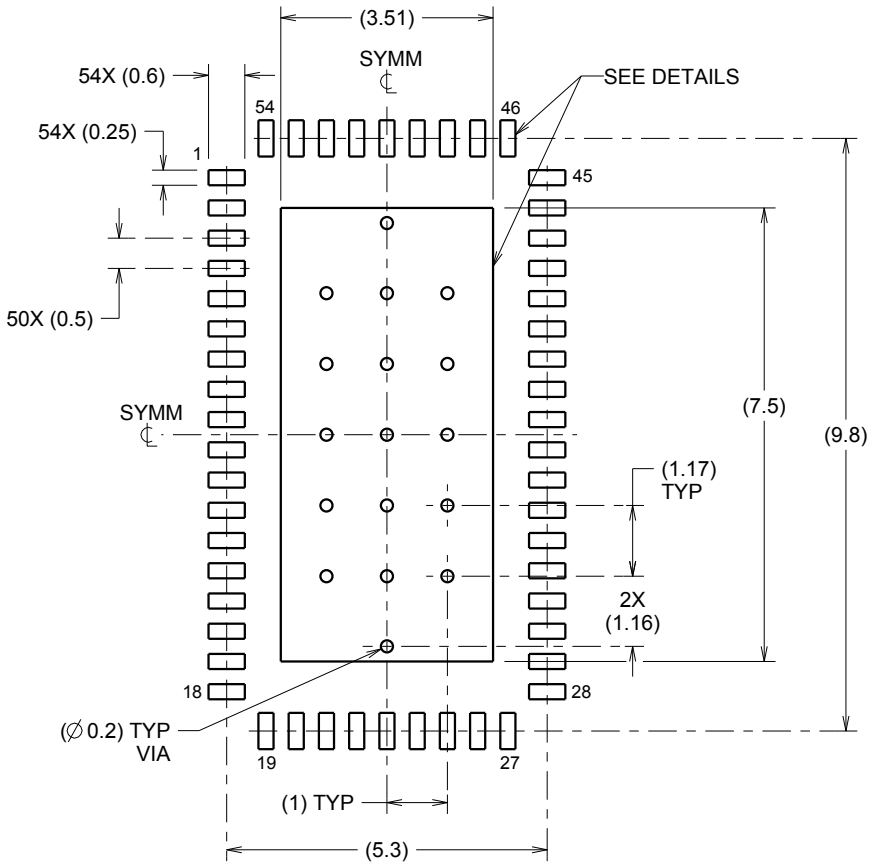
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS100KR800SQ/NOPB	WQFN	NJY	54	2000	356.0	356.0	36.0
DS100KR800SQE/NOPB	WQFN	NJY	54	250	208.0	191.0	35.0

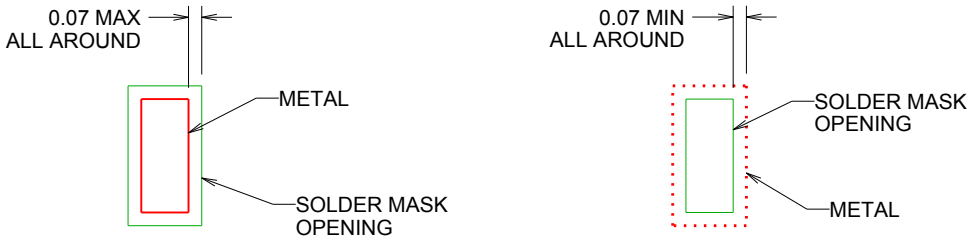


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE
SCALE:8X



NON SOLDER MASK
DEFINED
(PREFERRED)

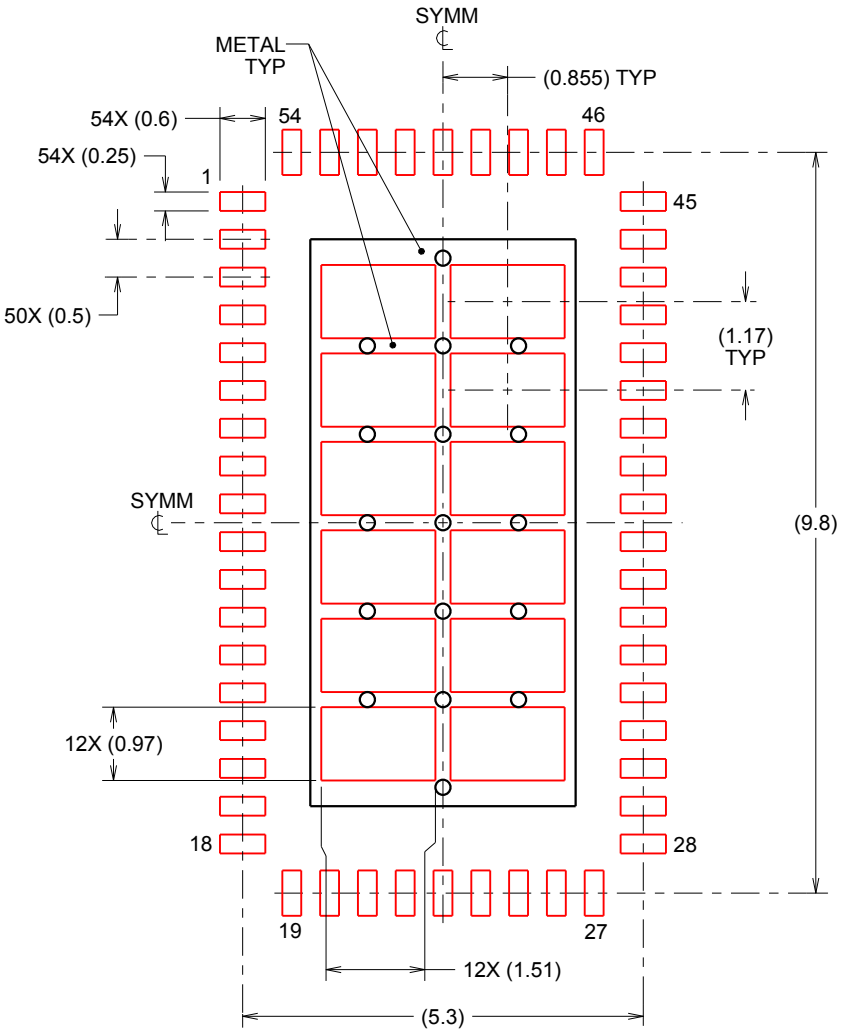
SOLDER MASK
DEFINED

SOLDER MASK DETAILS

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NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, refer to QFN/SON PCB application note in literature No. SLUA271 (www.ti.com/lit/slua271).



SOLDERPASTE EXAMPLE
BASED ON 0.125mm THICK STENCIL

EXPOSED PAD
67% PRINTED SOLDER COVERAGE BY AREA
SCALE:10X

4214993/A 07/2013

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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